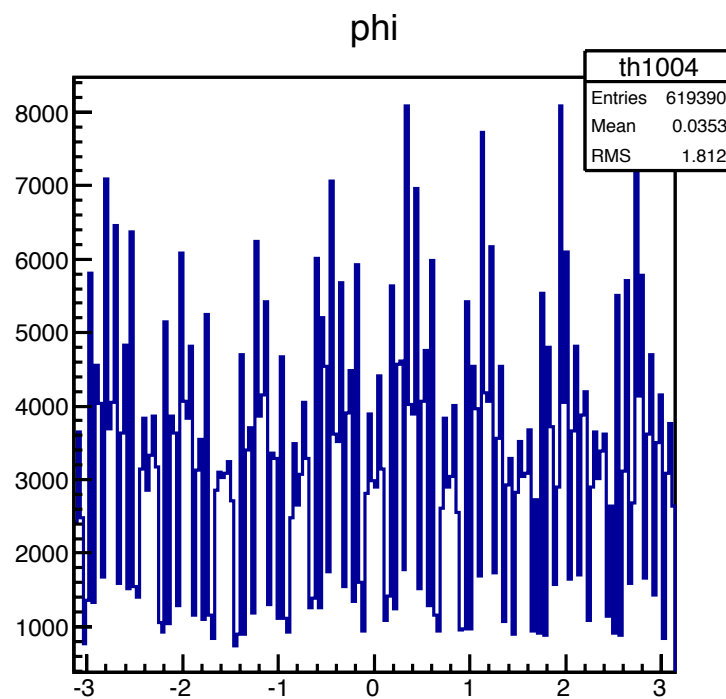
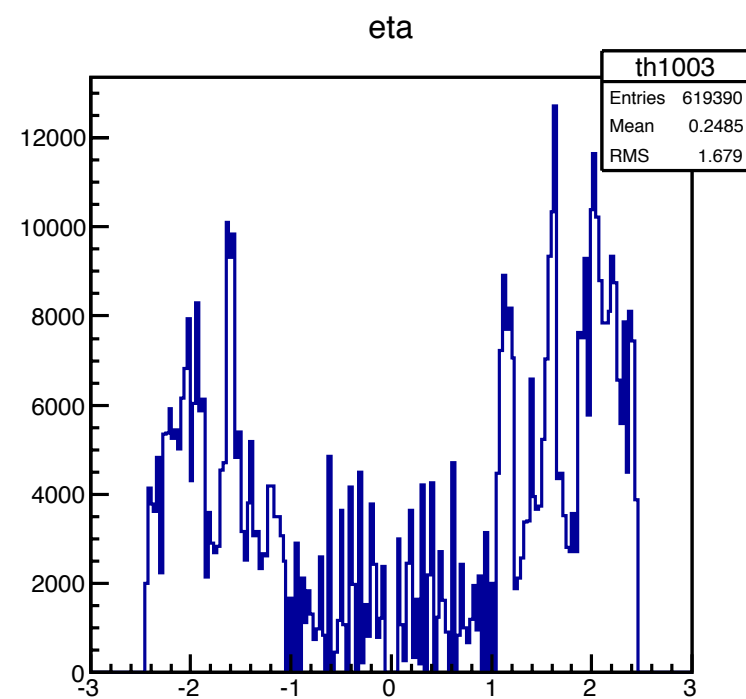
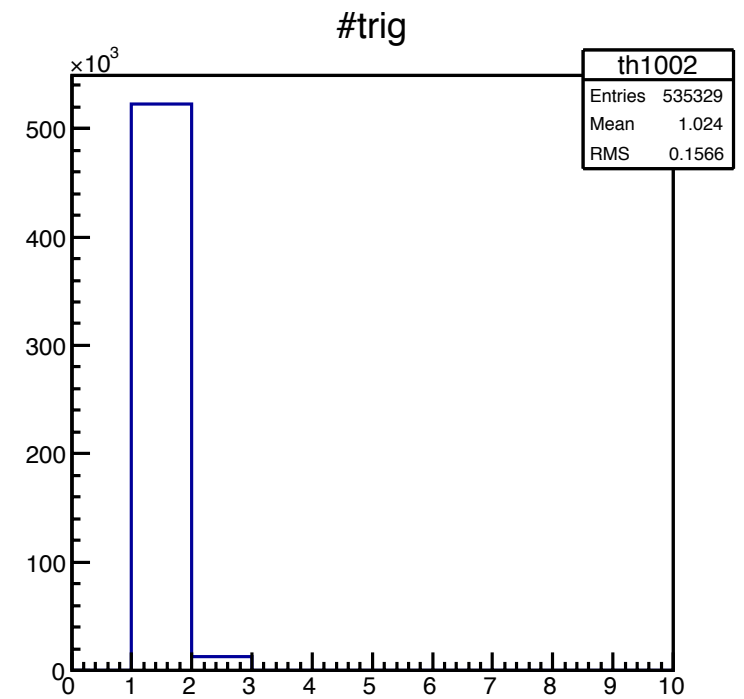
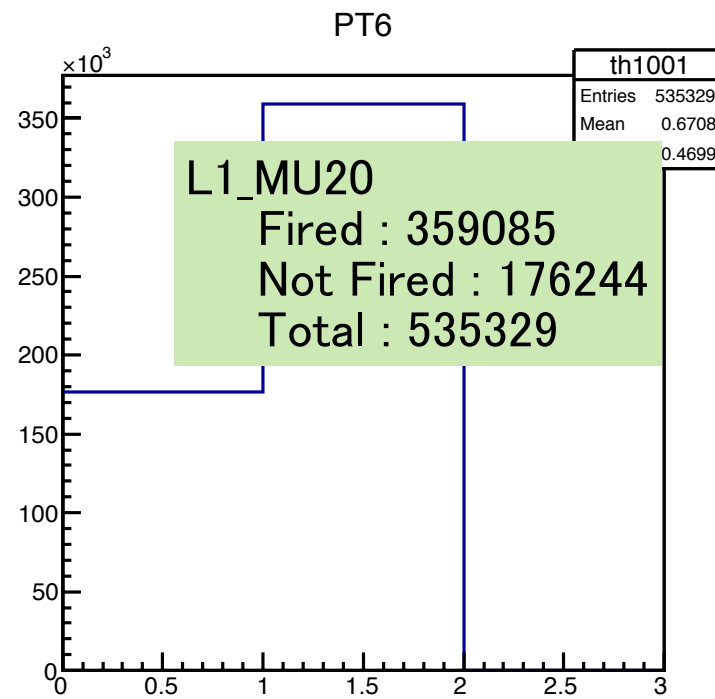
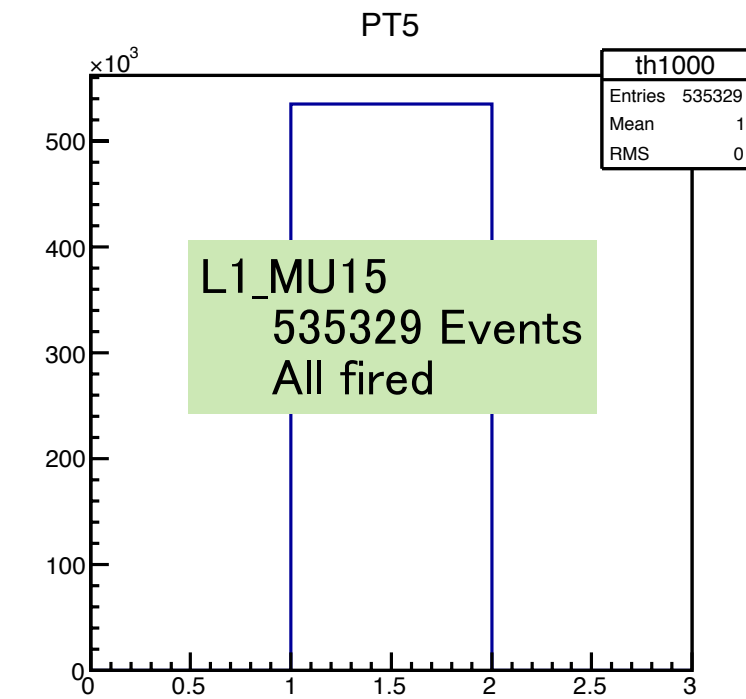


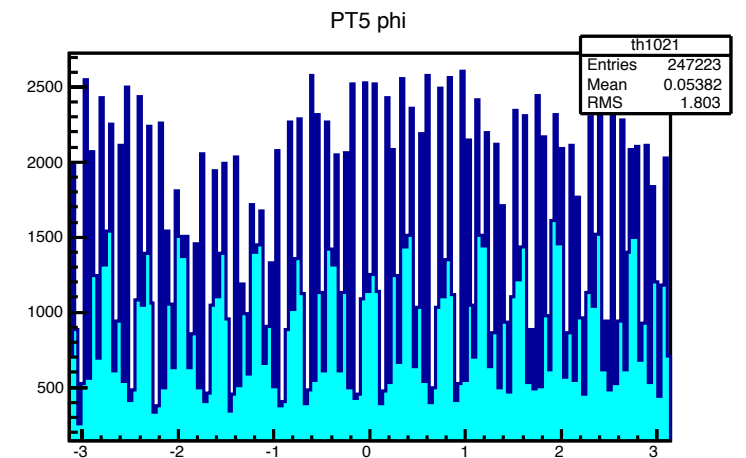
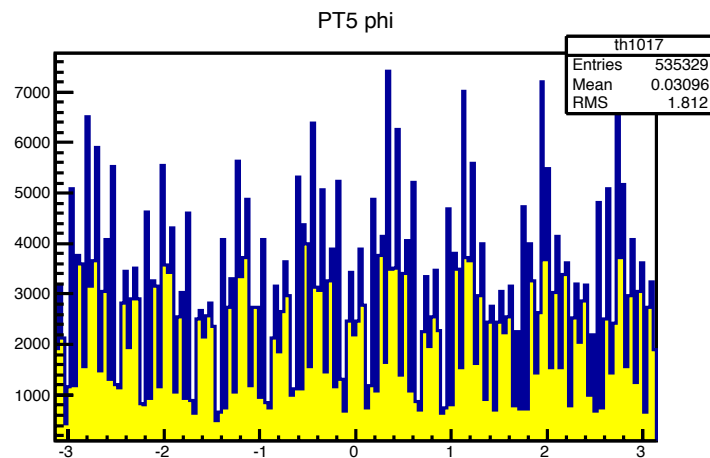
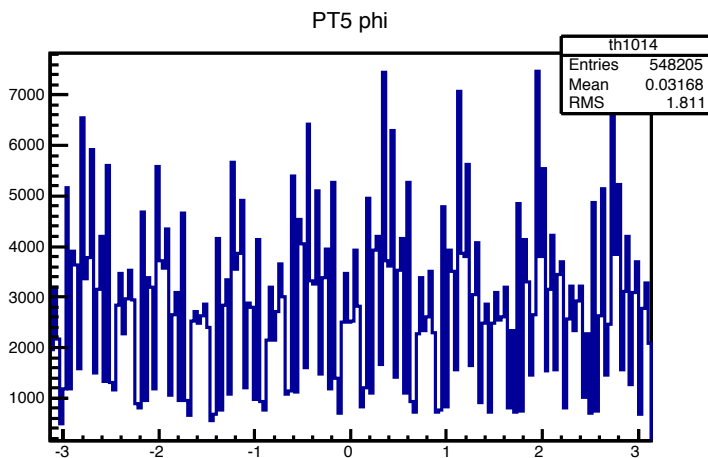
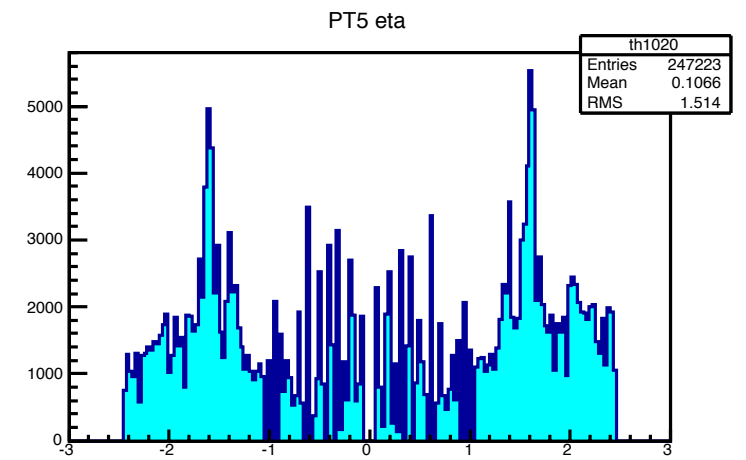
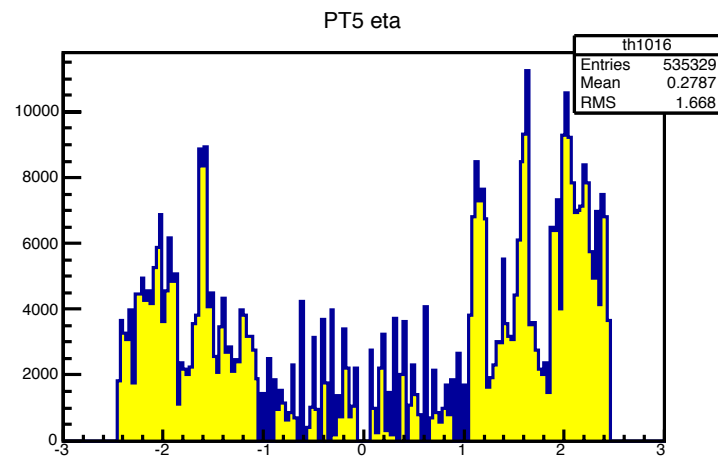
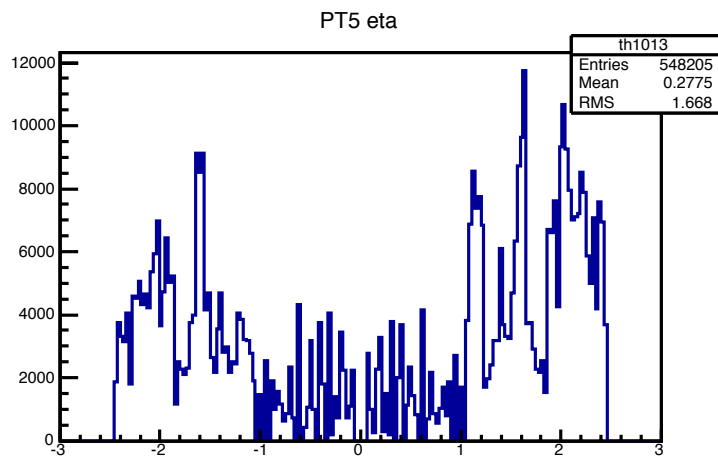
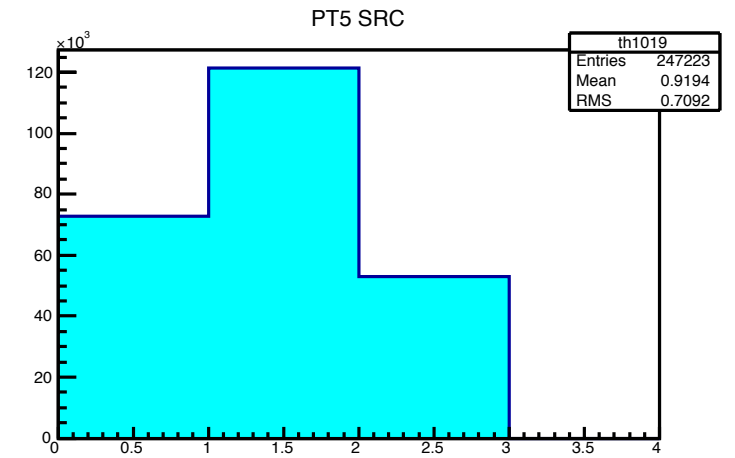
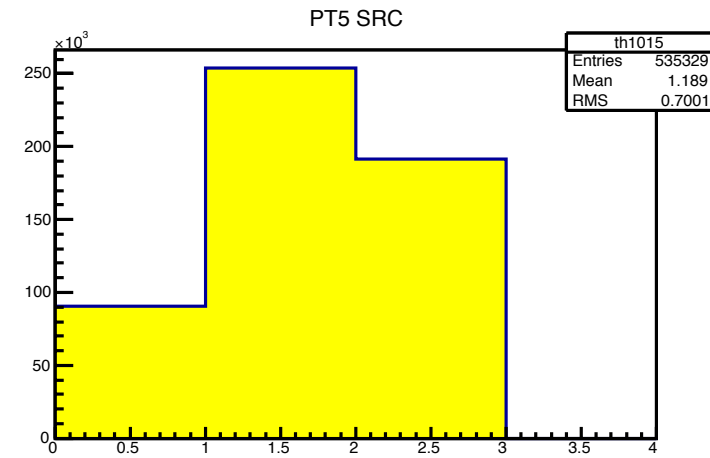
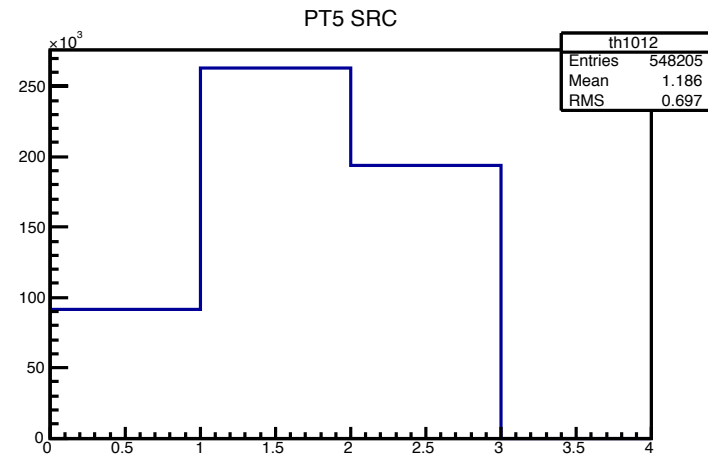
京都ATLAS meeting

EI/FI cut後
Tile cut前 (S2)

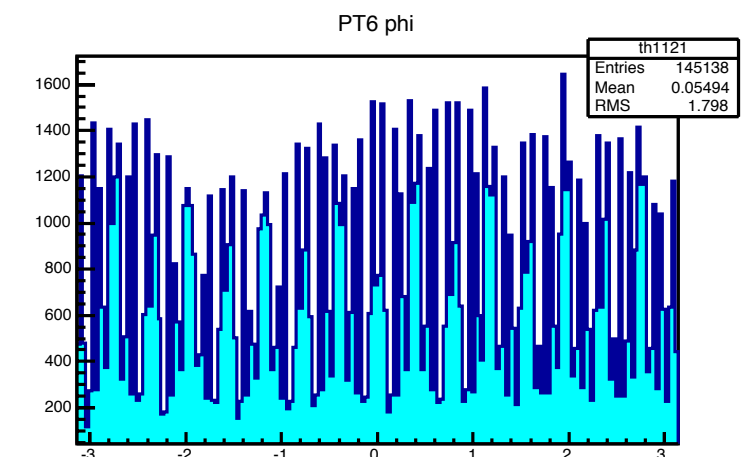
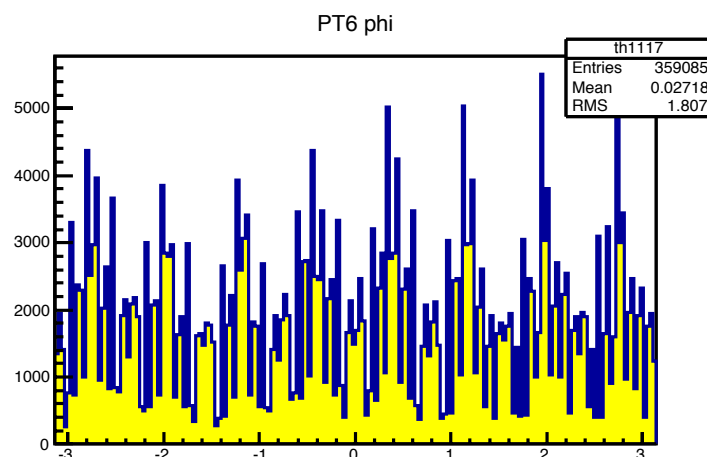
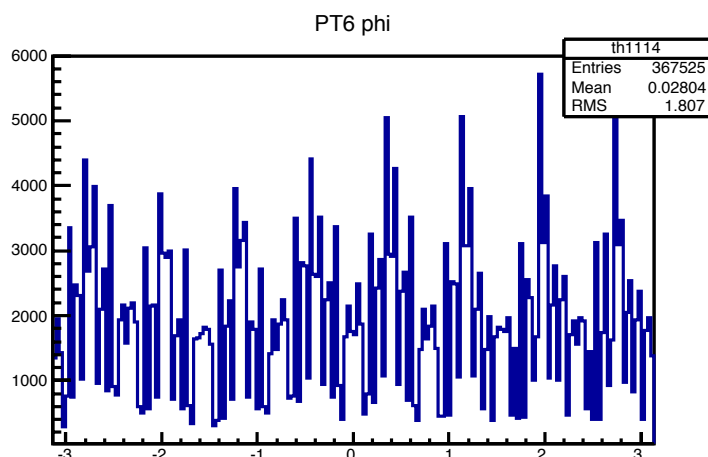
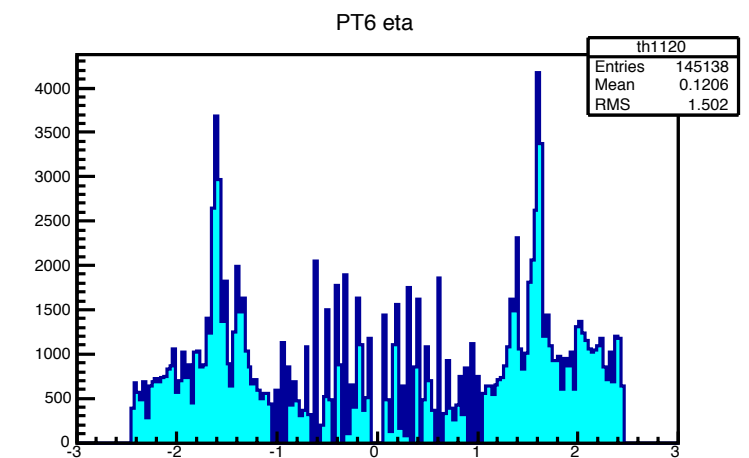
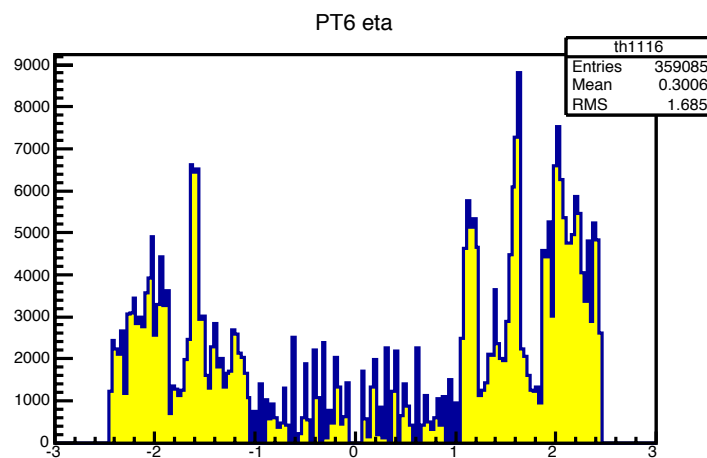
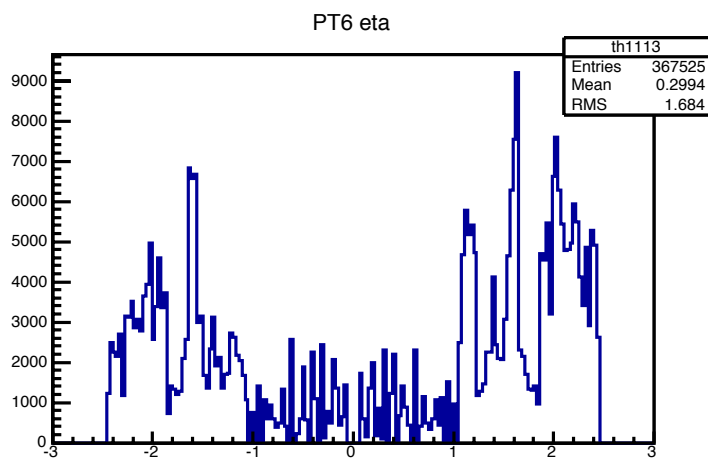
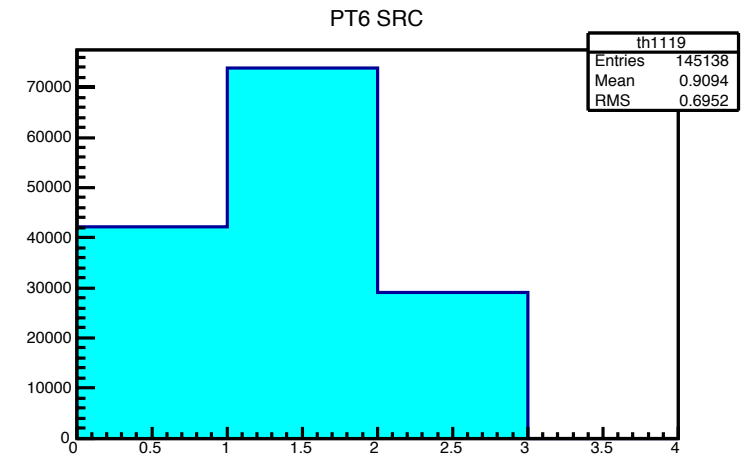
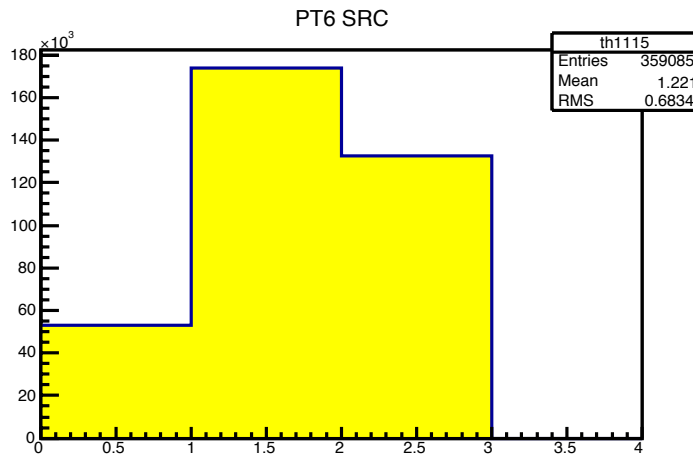
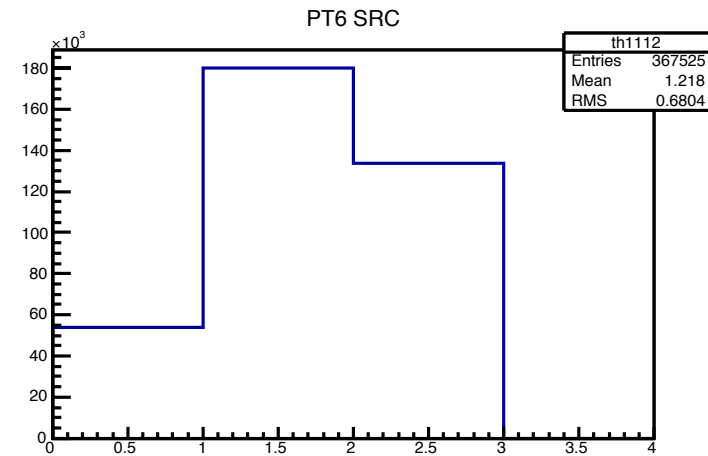
S2 : Basic Histograms



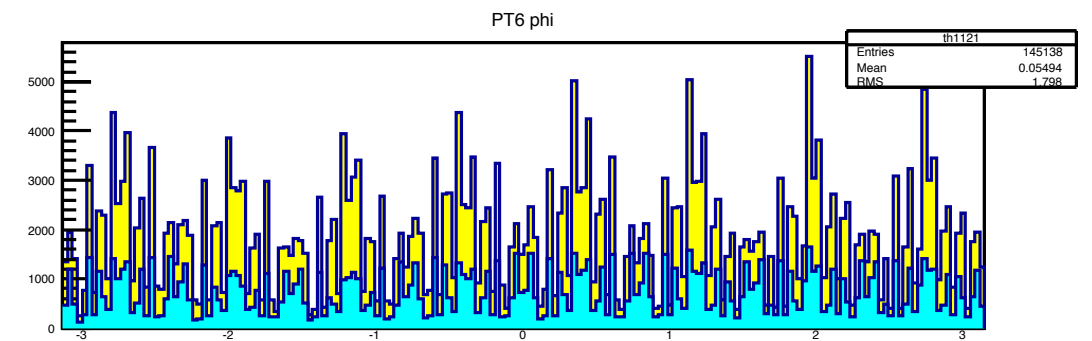
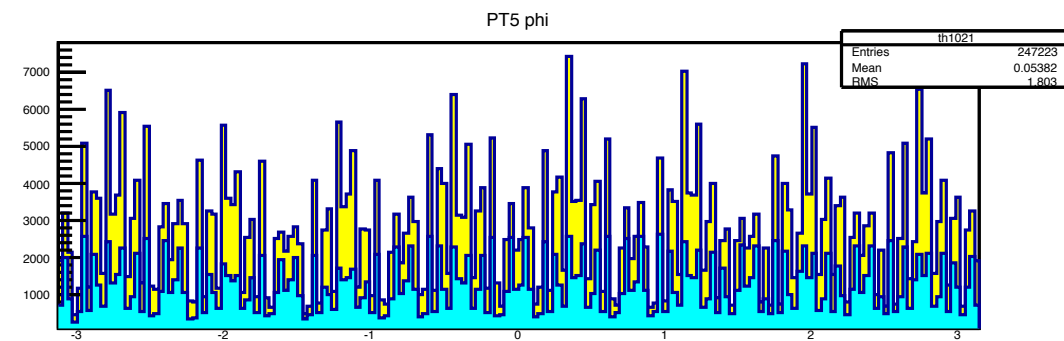
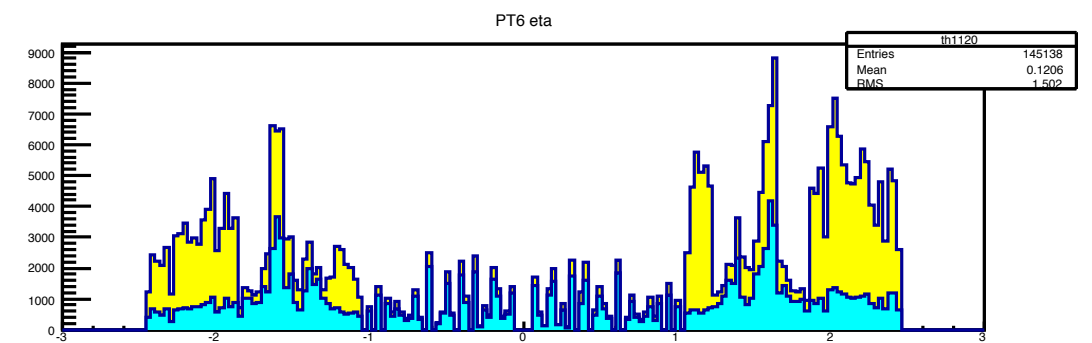
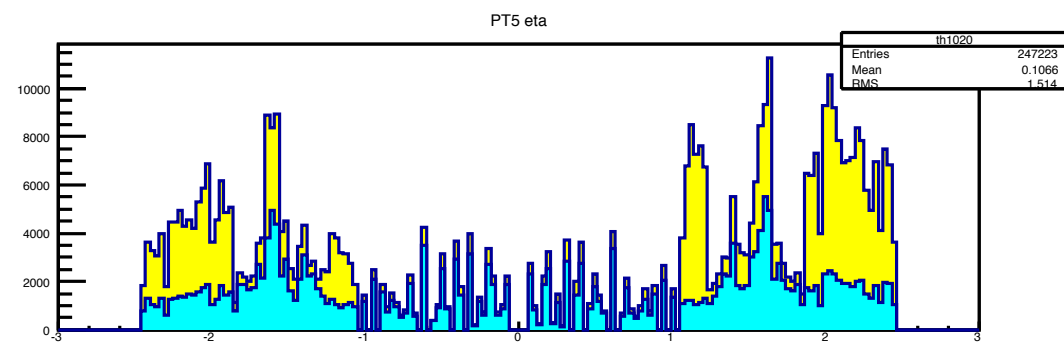
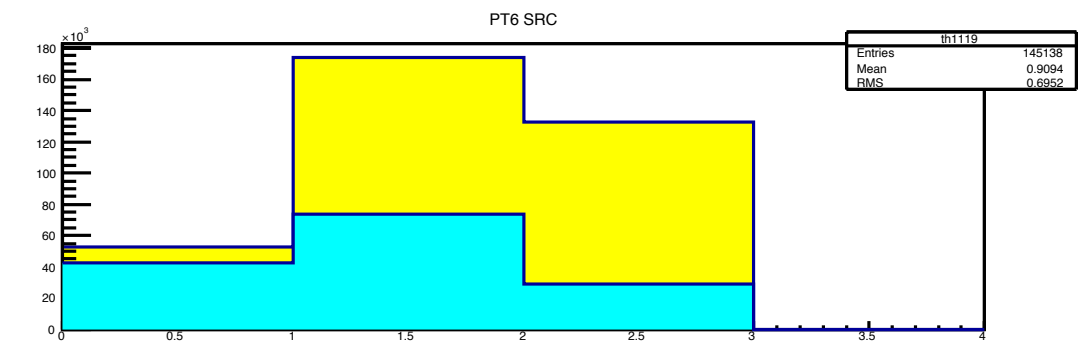
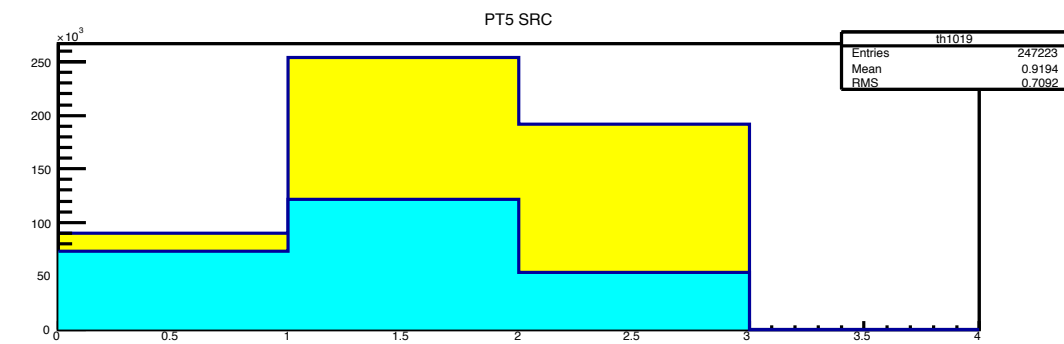
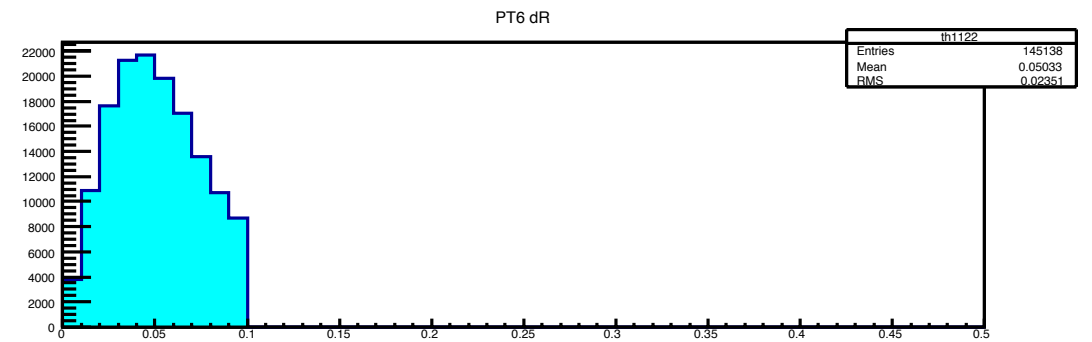
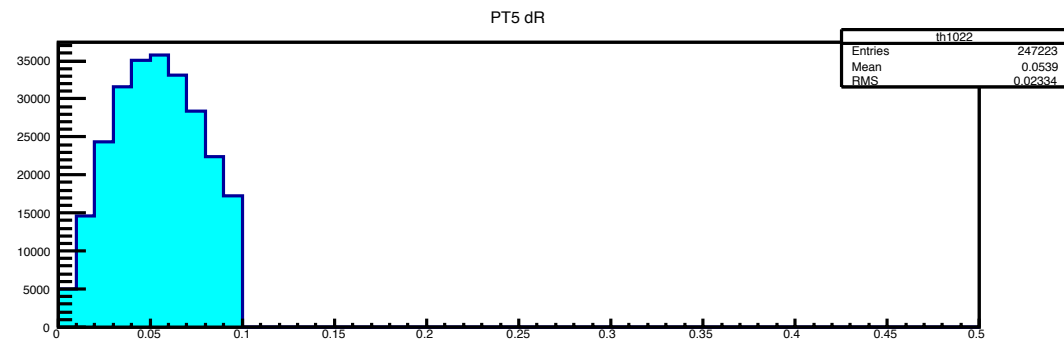
S2:pT5



S2:pT6

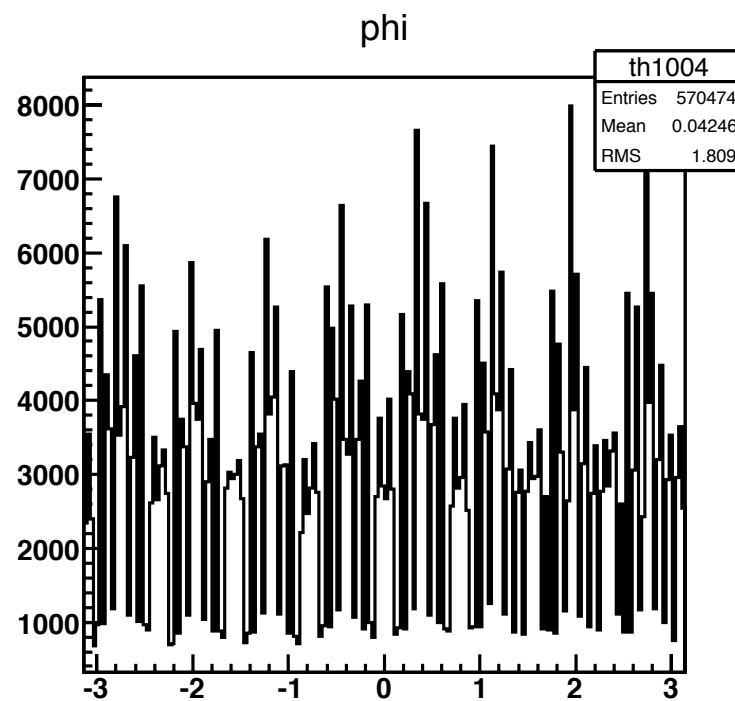
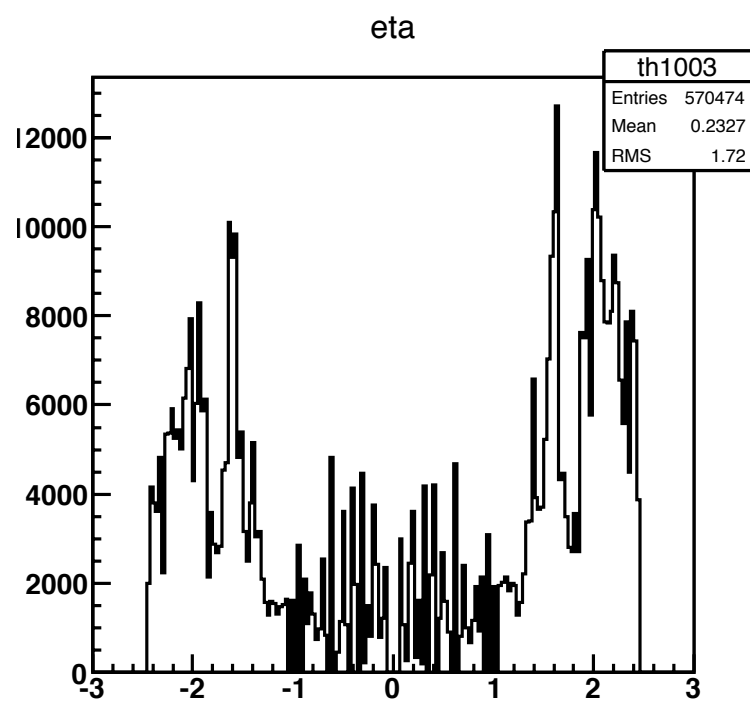
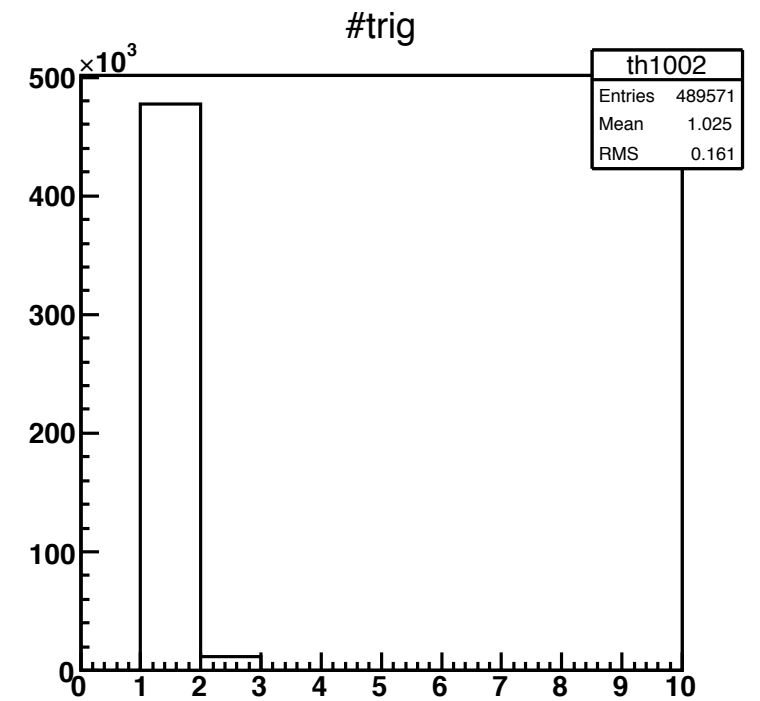
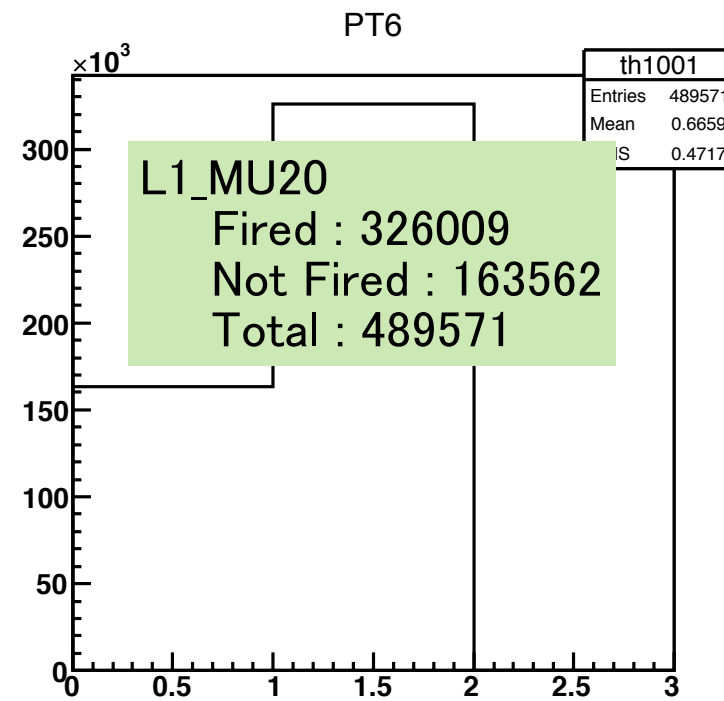
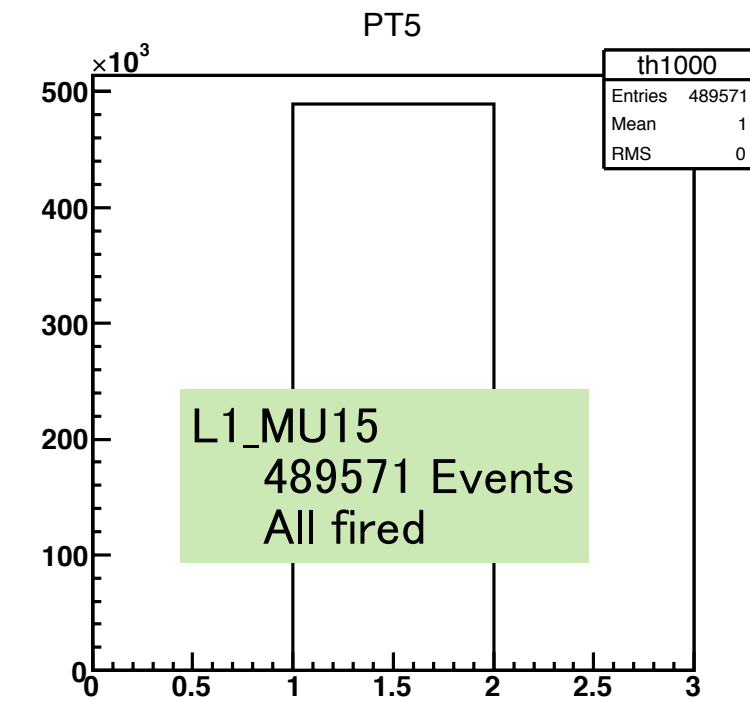


S2:黄色 青 重ね書き

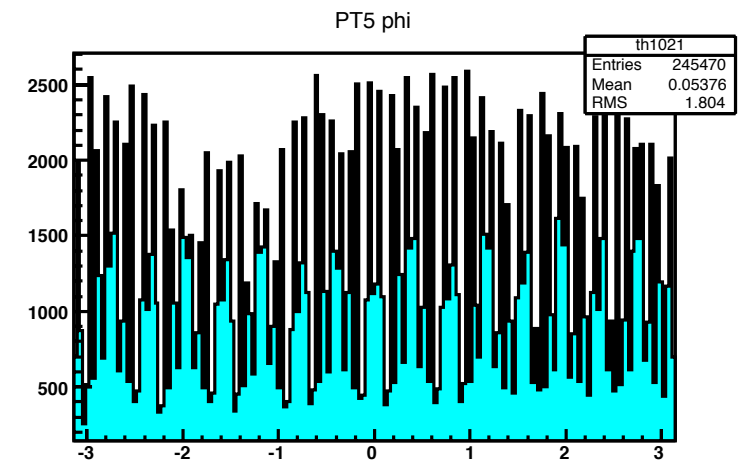
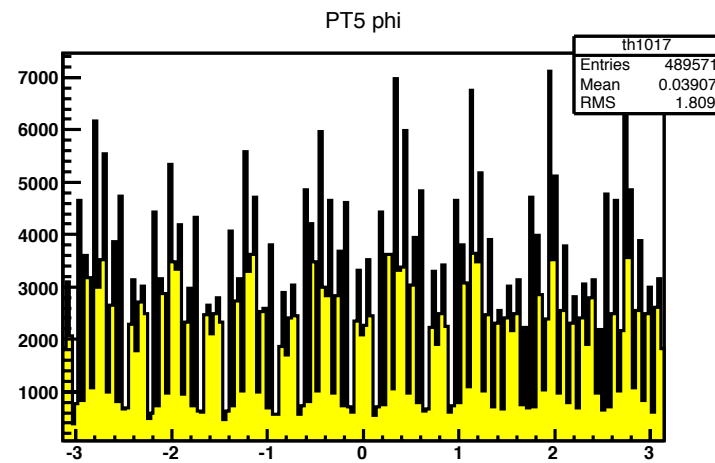
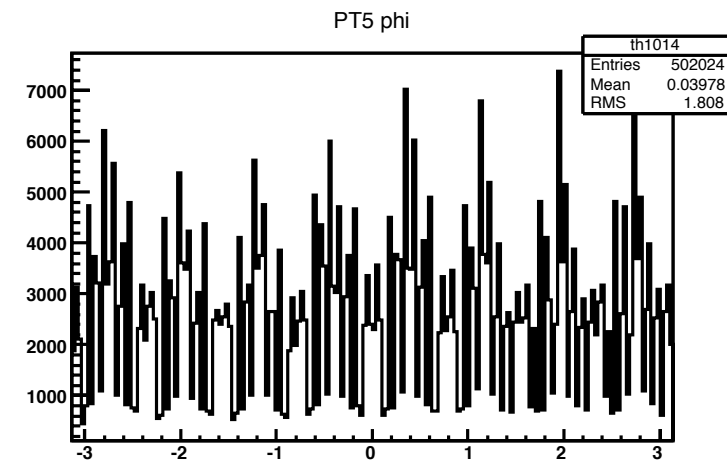
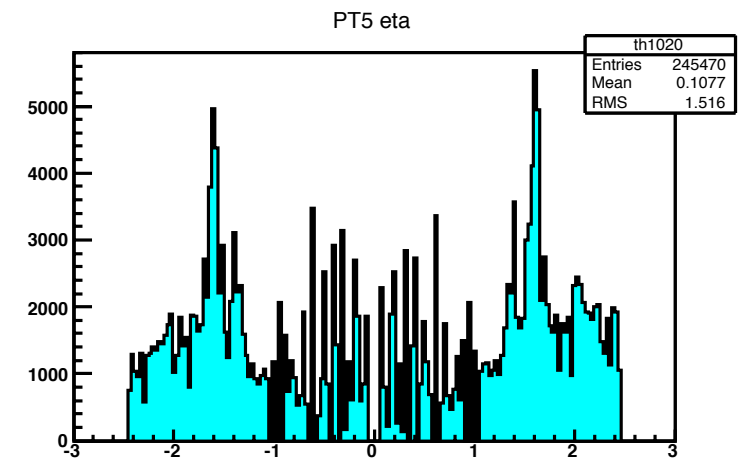
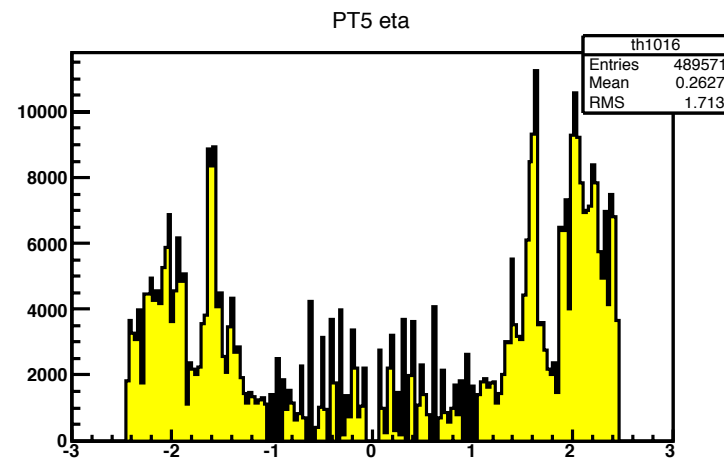
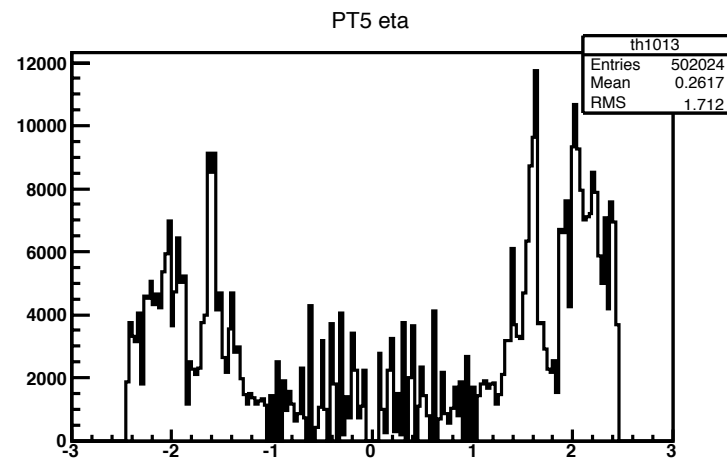
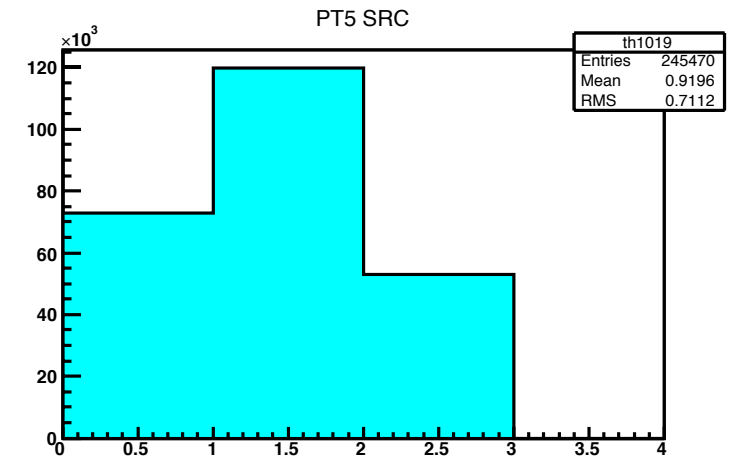
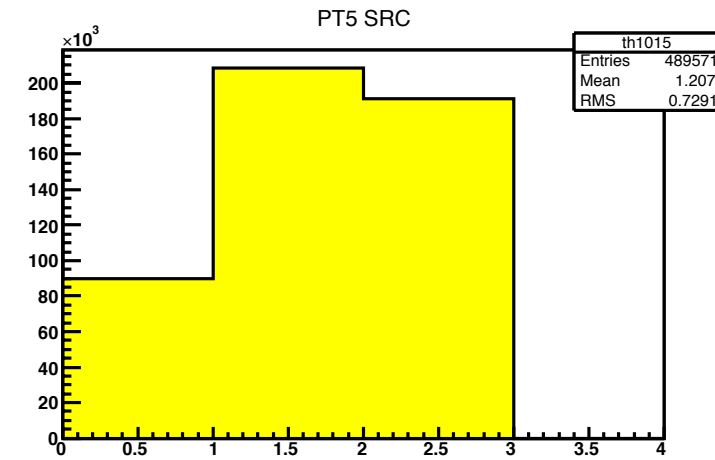
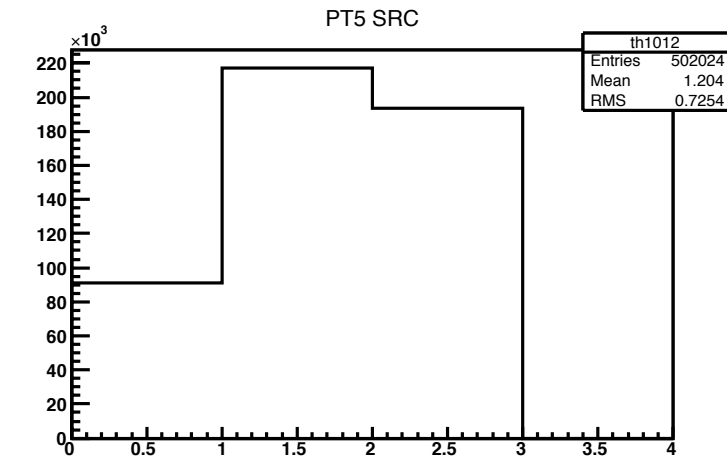


tile cut後
NSW cut前 (S3)

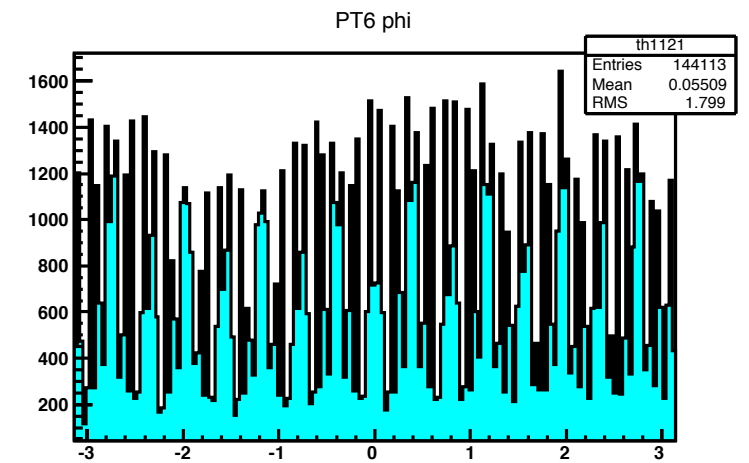
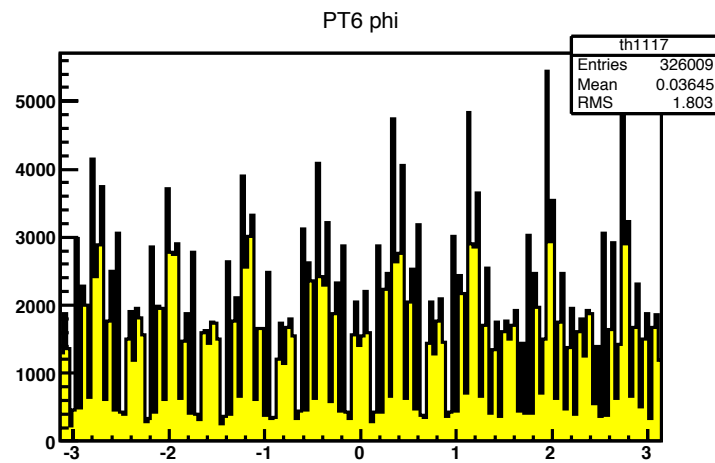
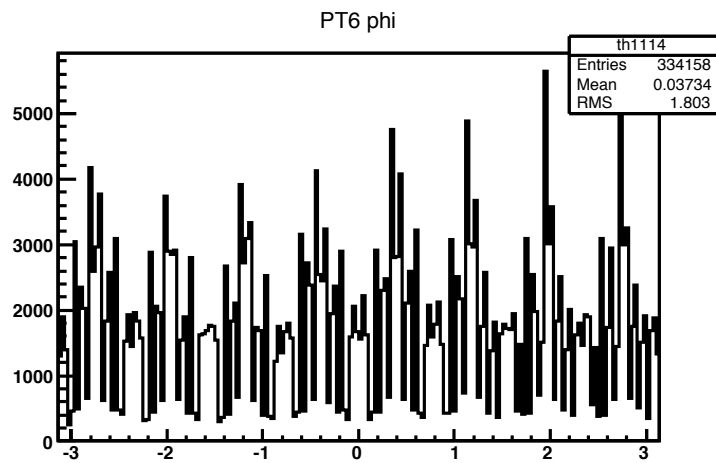
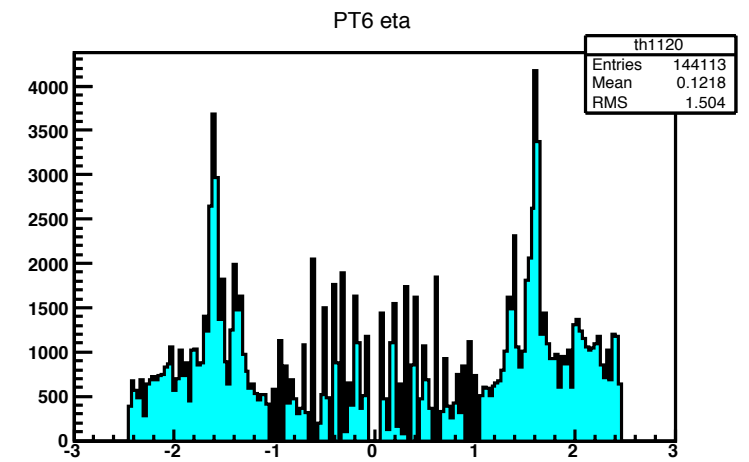
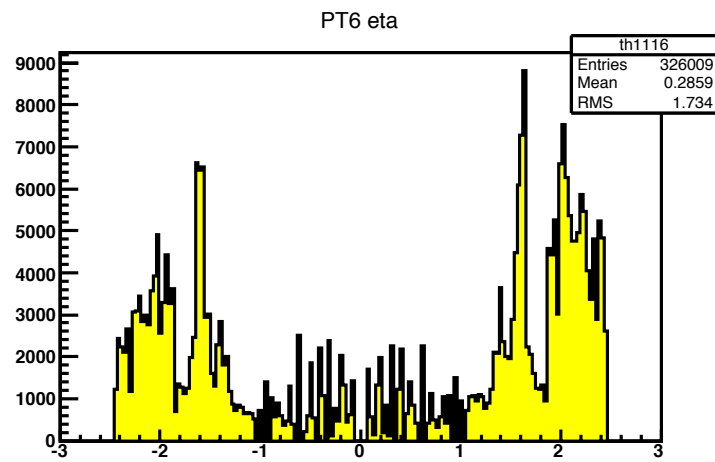
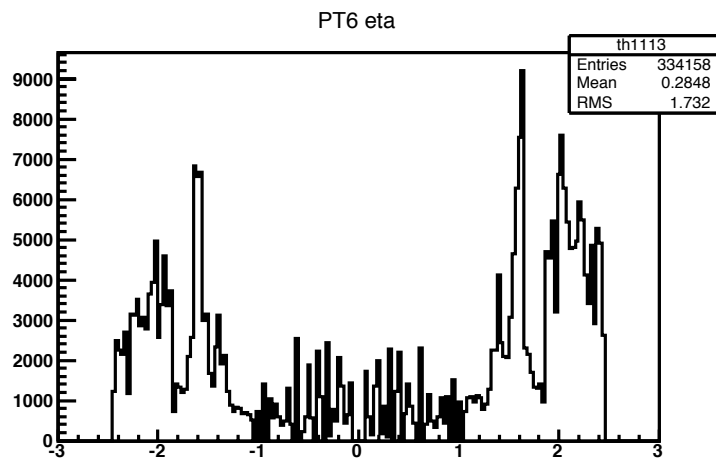
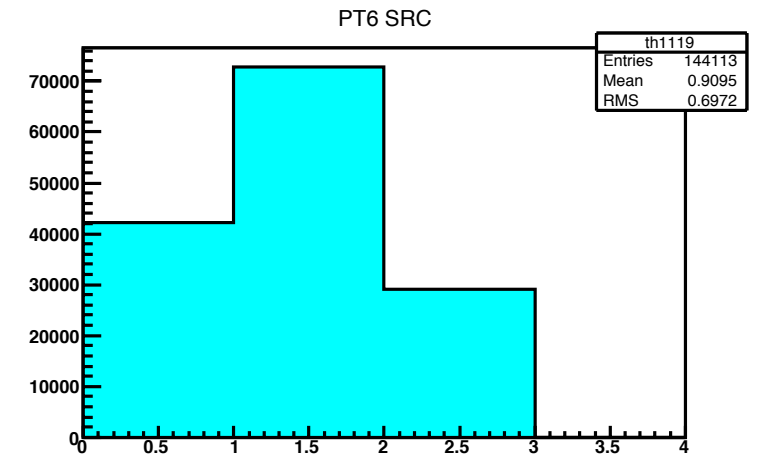
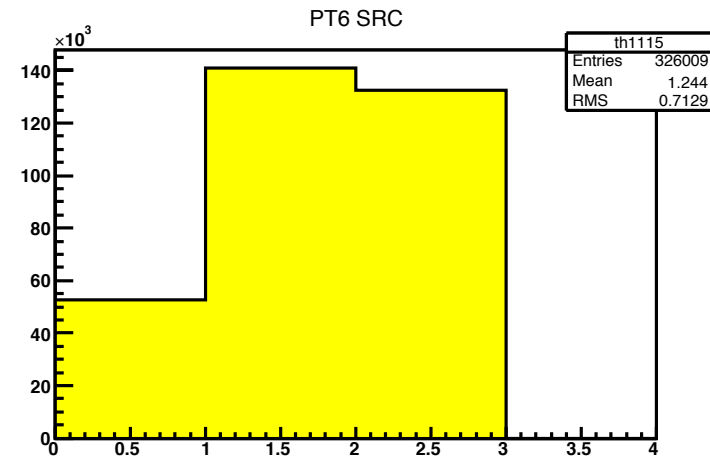
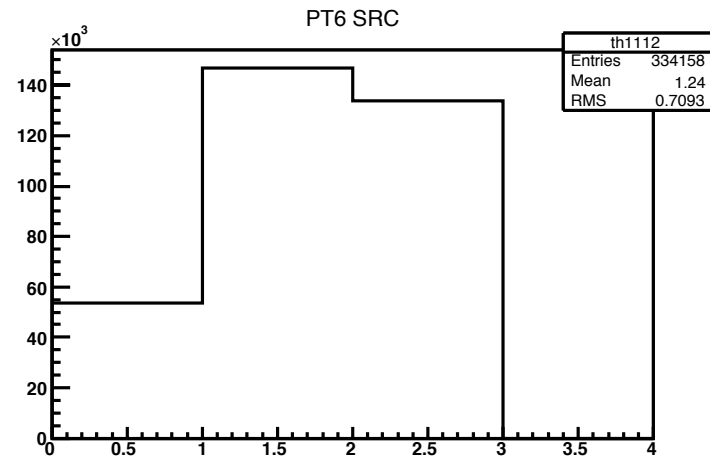
S3 : Basic Histograms



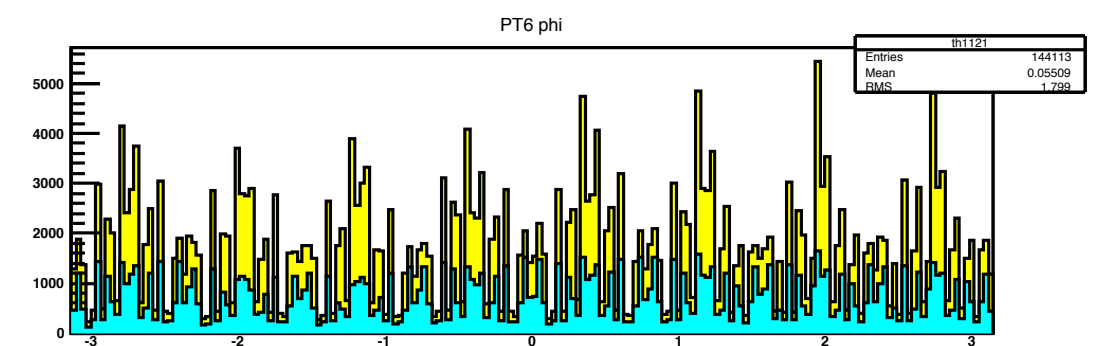
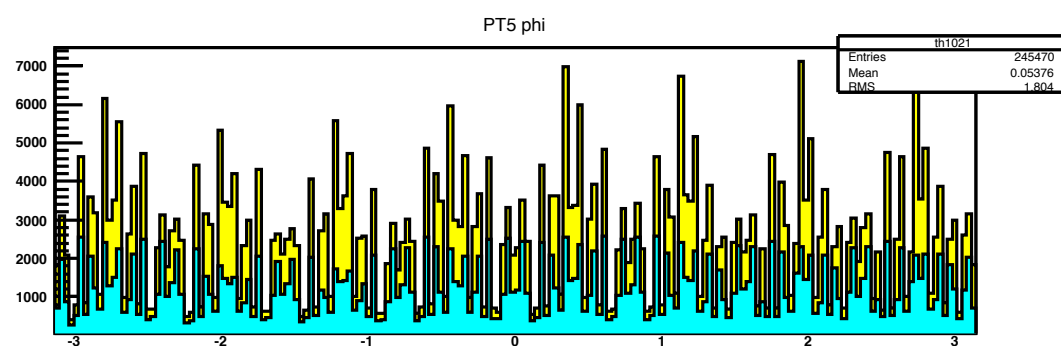
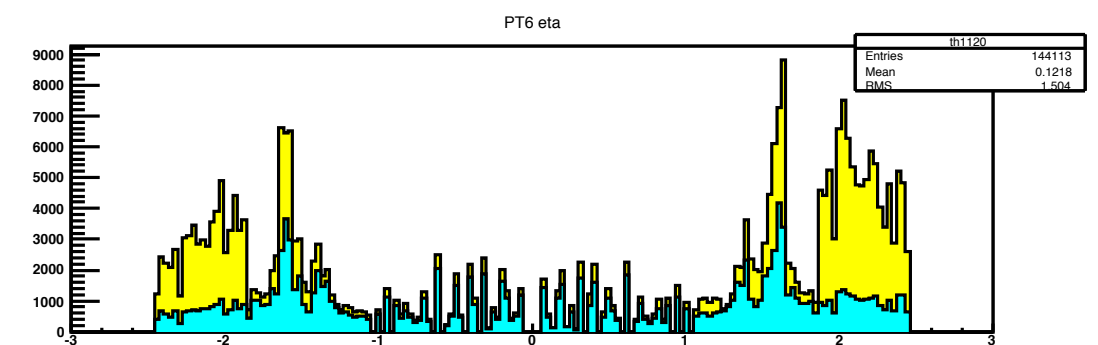
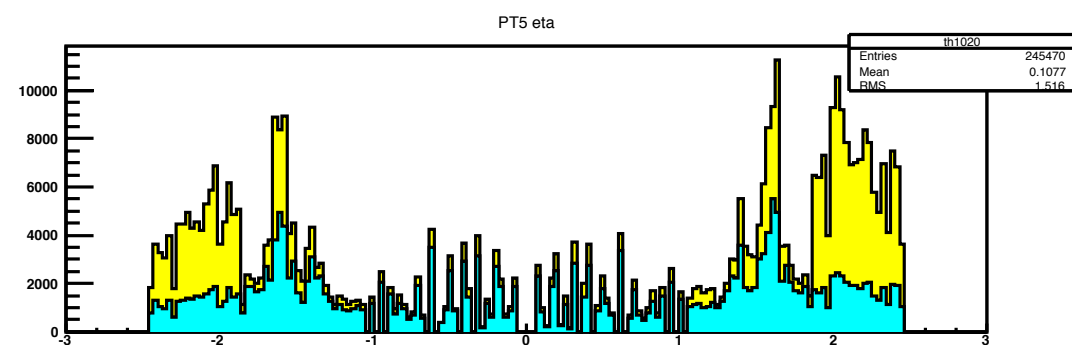
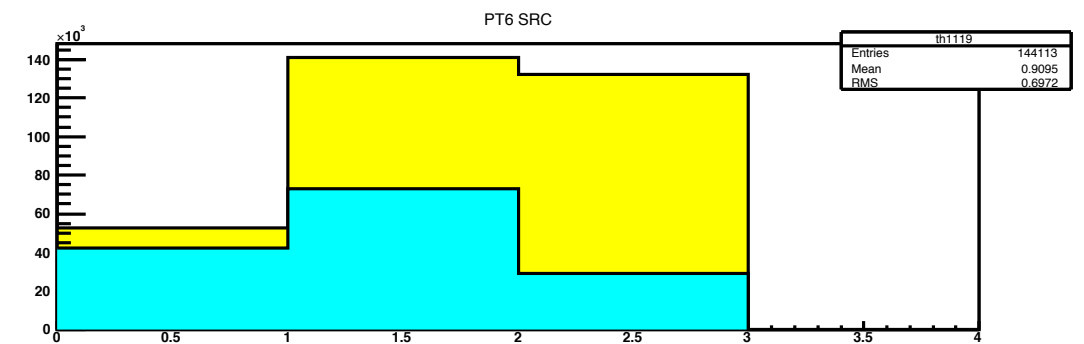
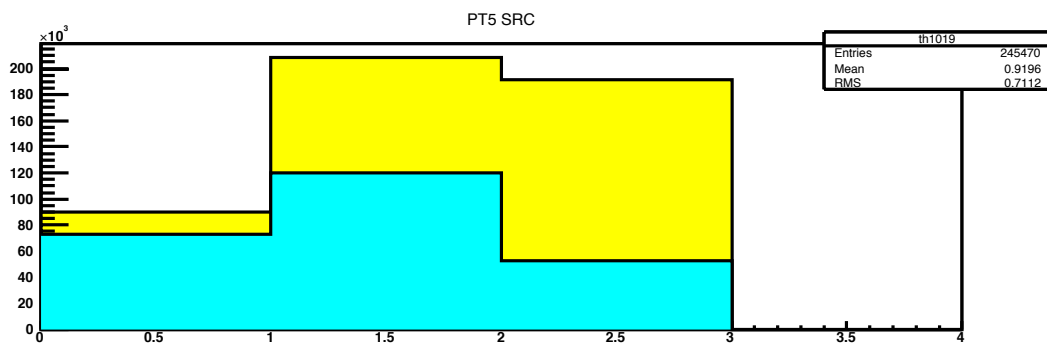
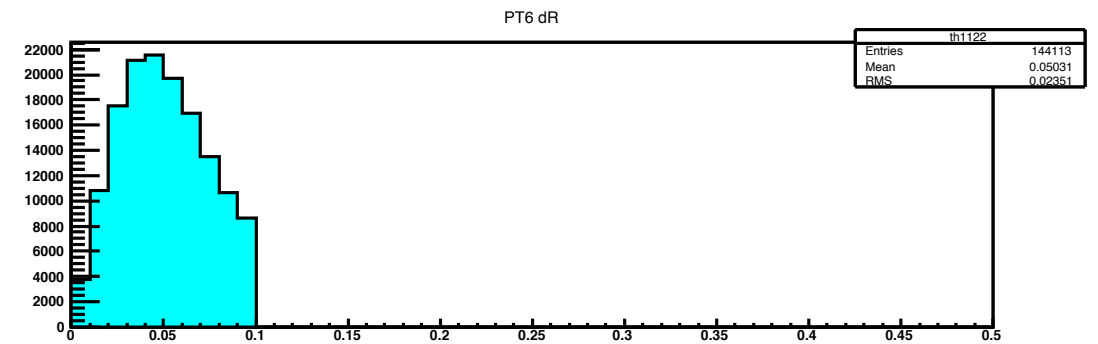
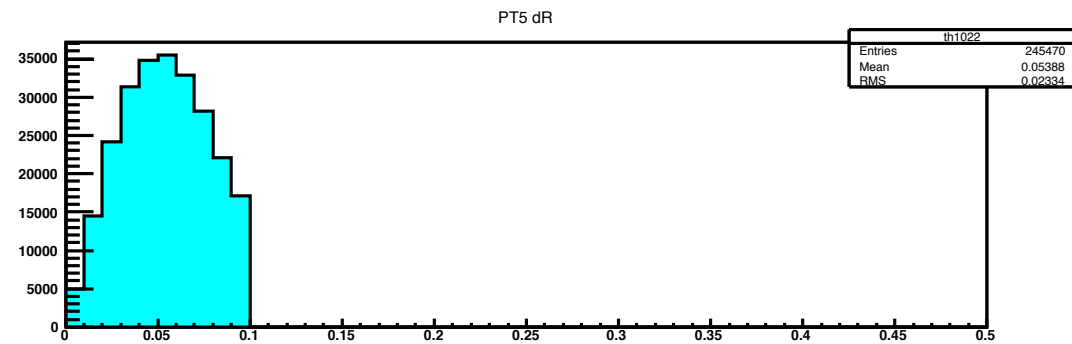
S3:pT5



S3:pT6



S3:黄色 青 重ね書き



NSW cut後 (S4)

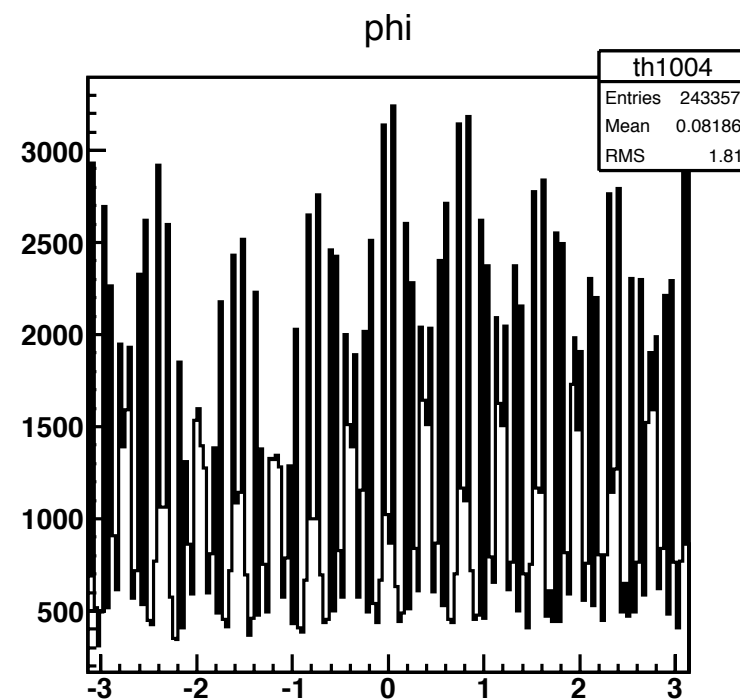
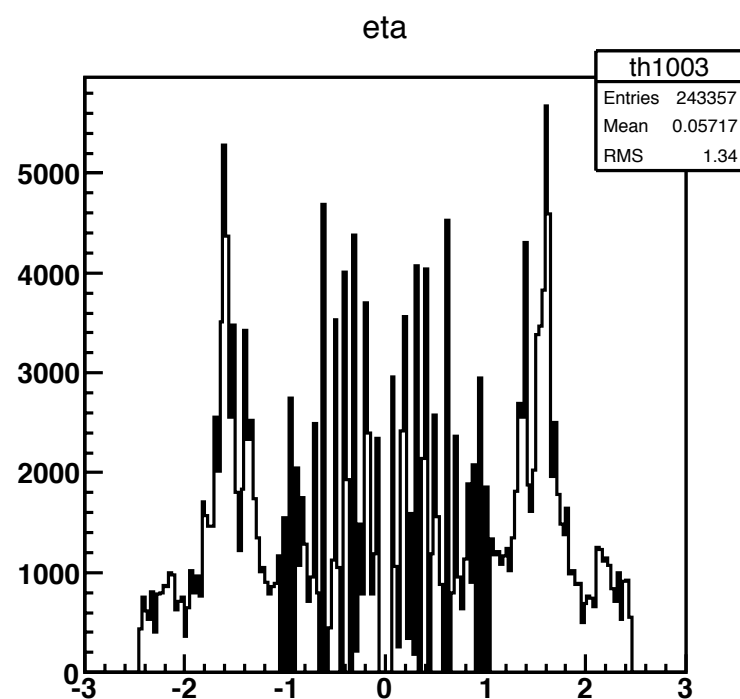
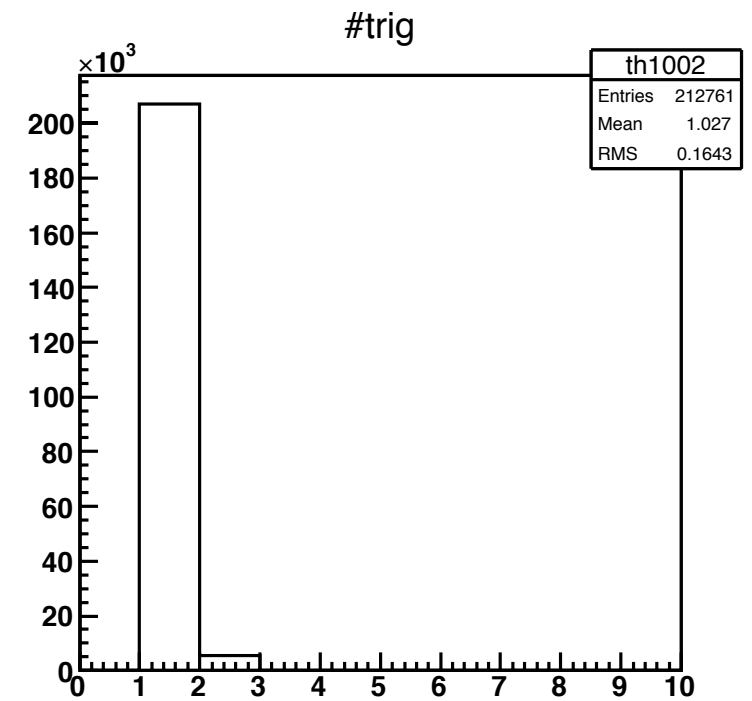
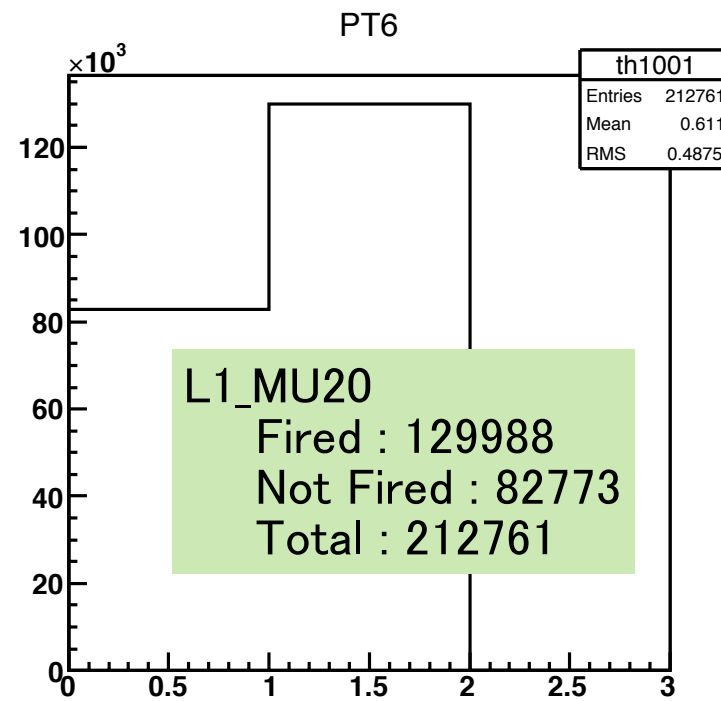
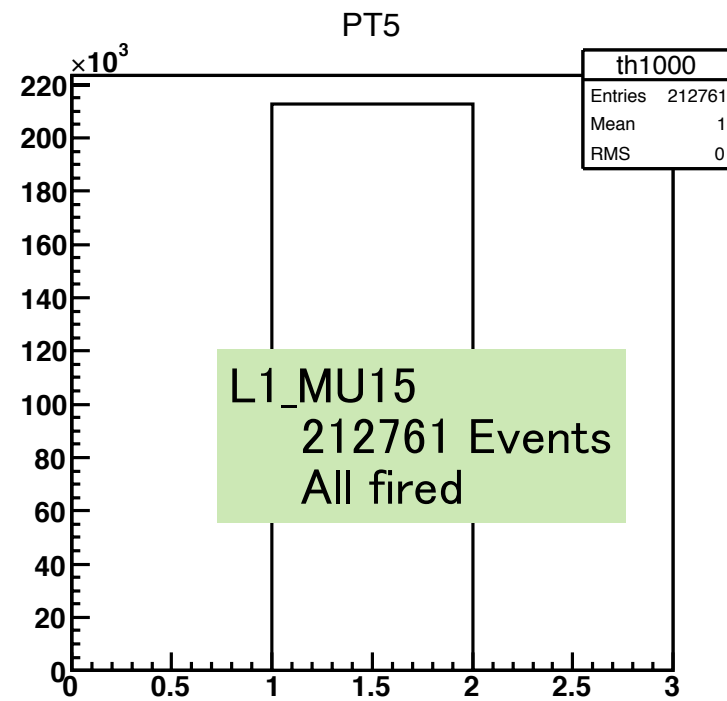
NSW cut条件

$$d\eta = \eta(\text{RoI}) - \eta(\text{track segment})$$

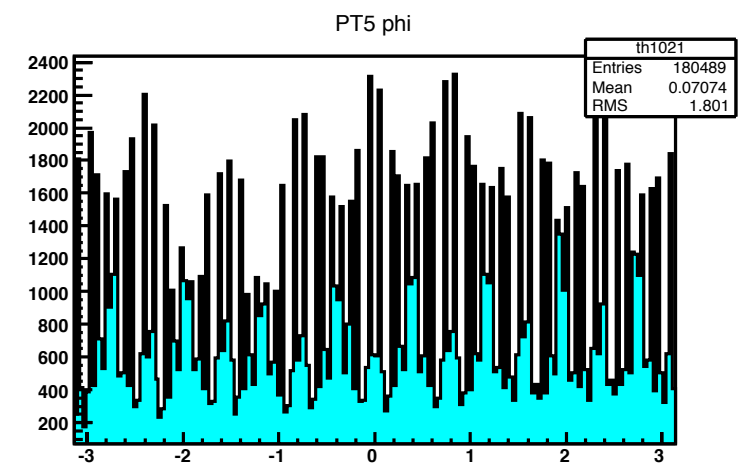
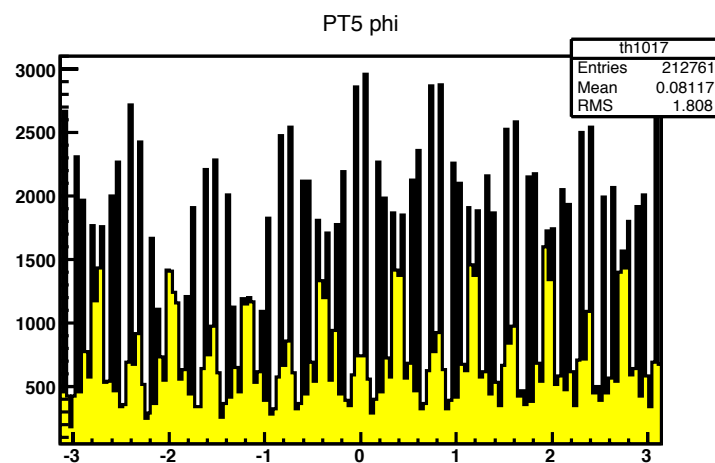
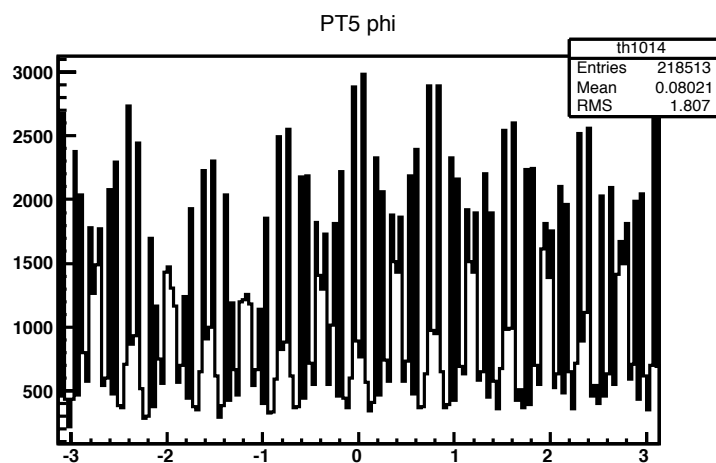
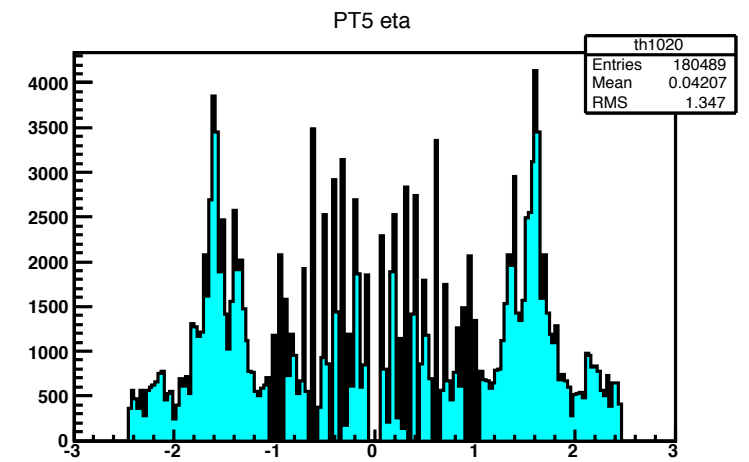
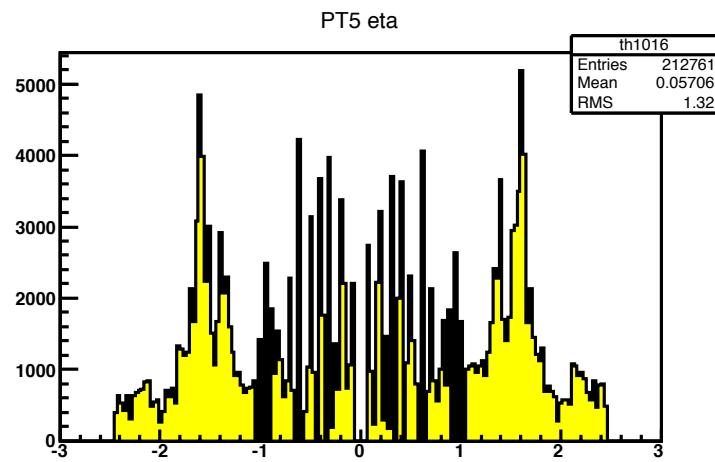
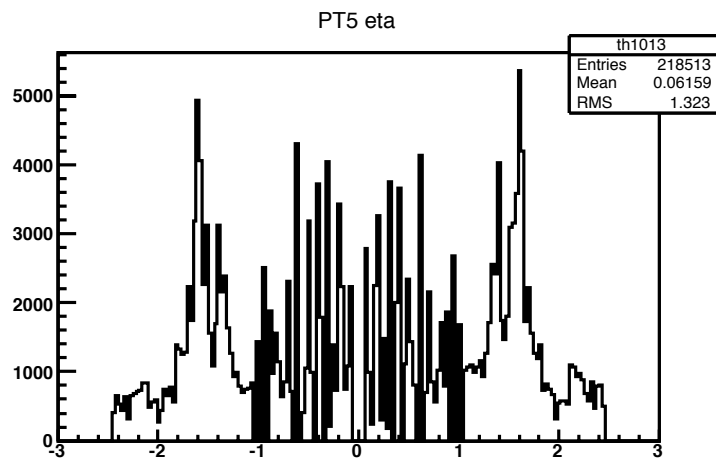
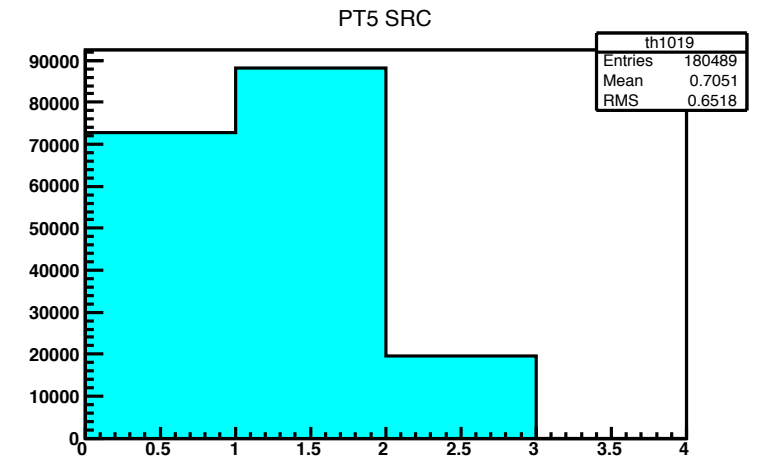
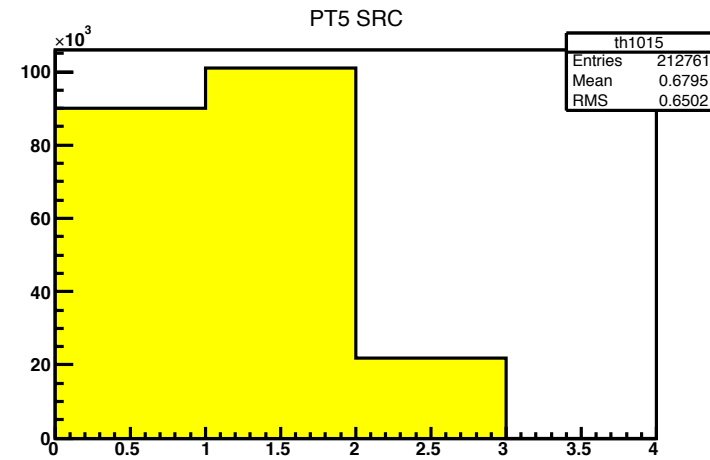
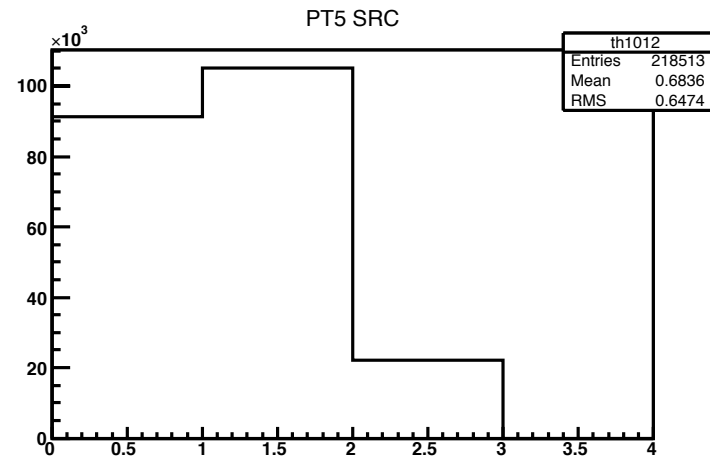
$$d\Phi = \Phi(\text{RoI}) - \Phi(\text{track segment})$$

	$d\theta$	$d\eta$	$d\Phi$
$1.3 < \eta < 1.5$	0.015	0.05	0.06
$1.5 < \eta < 1.7$	0.015	0.05	0.06
$1.7 < \eta < 1.9$	0.010	0.05	0.06
$1.9 < \eta < 2.1$	0.025	0.05	0.06
$2.1 < \eta < 2.3$	0.07	0.07	0.06
$2.3 < \eta $	0.07	0.07	0.06

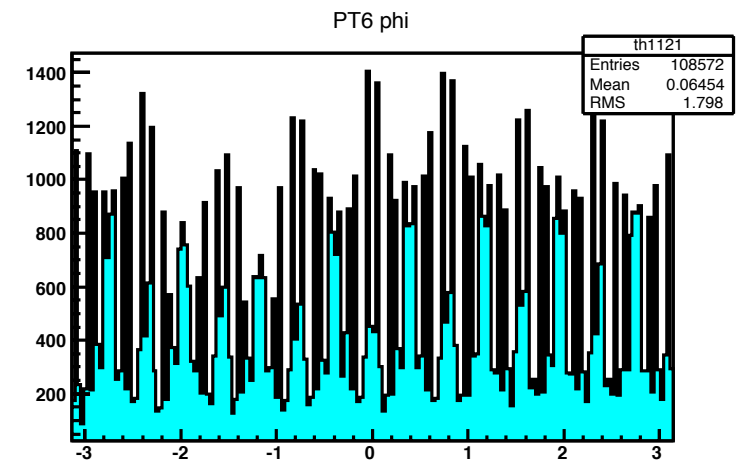
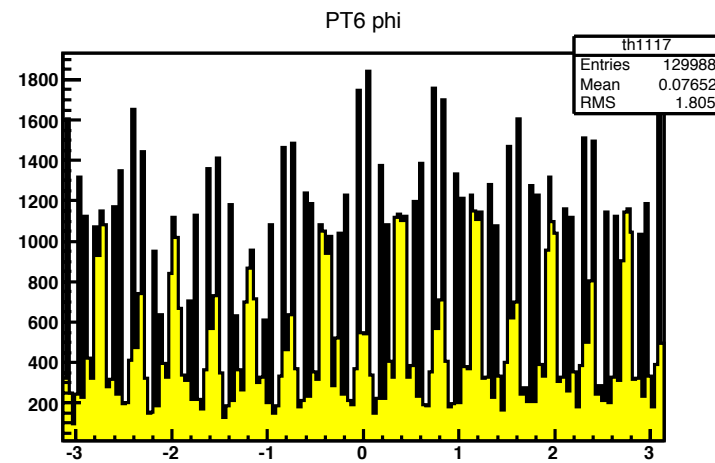
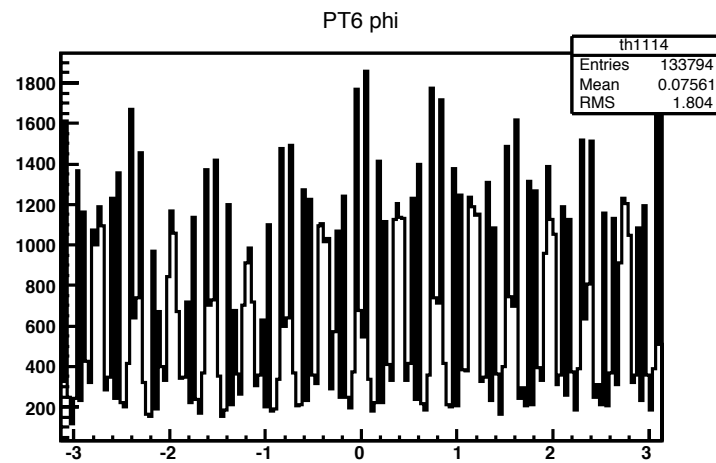
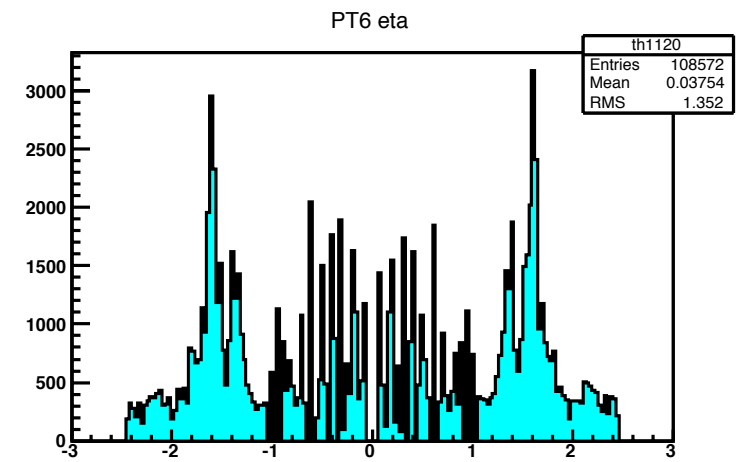
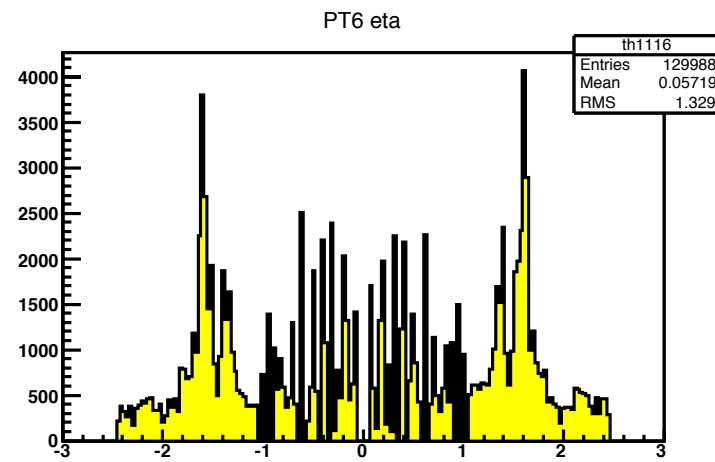
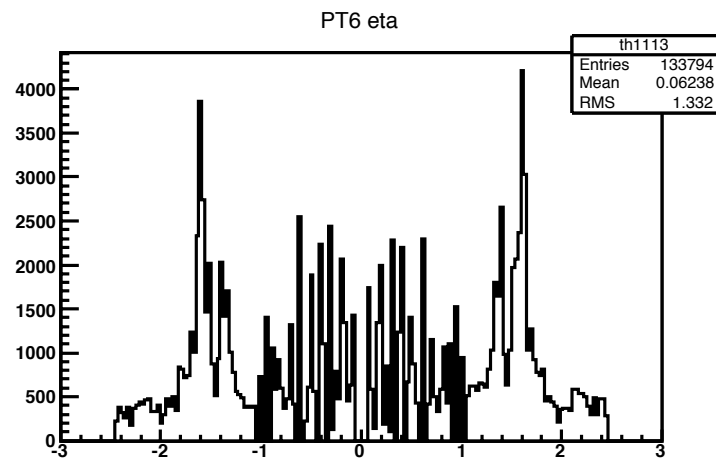
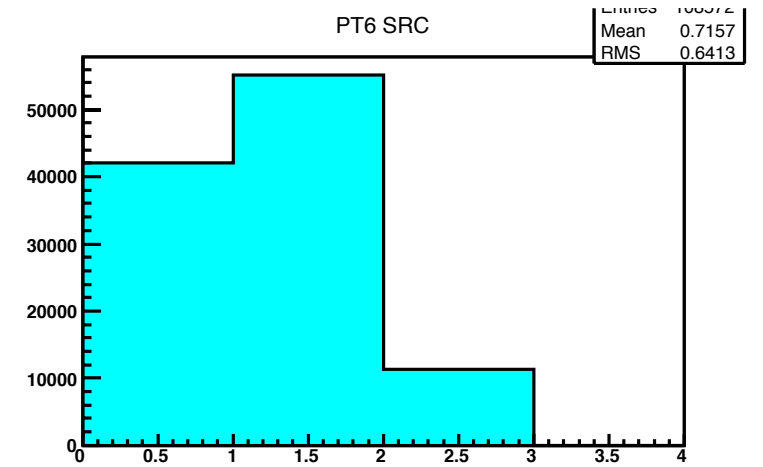
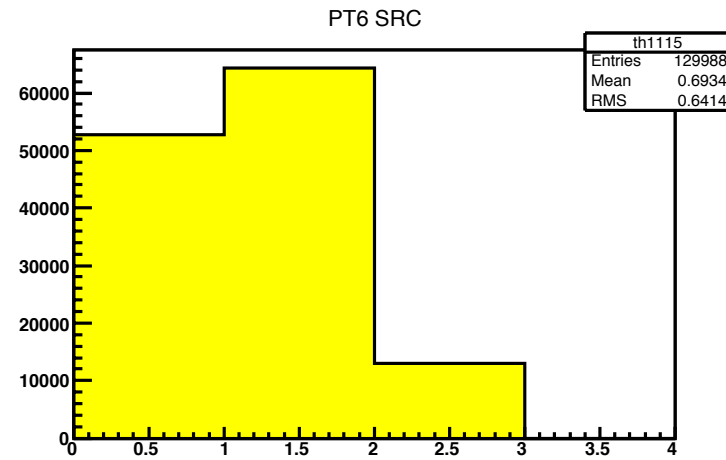
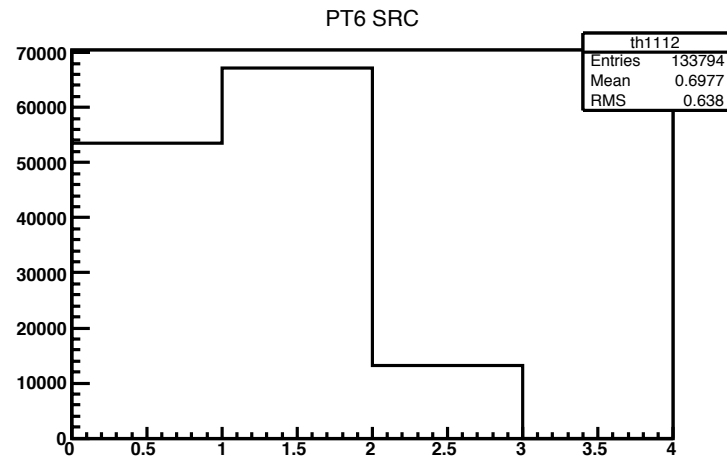
S4 : Basic Histograms



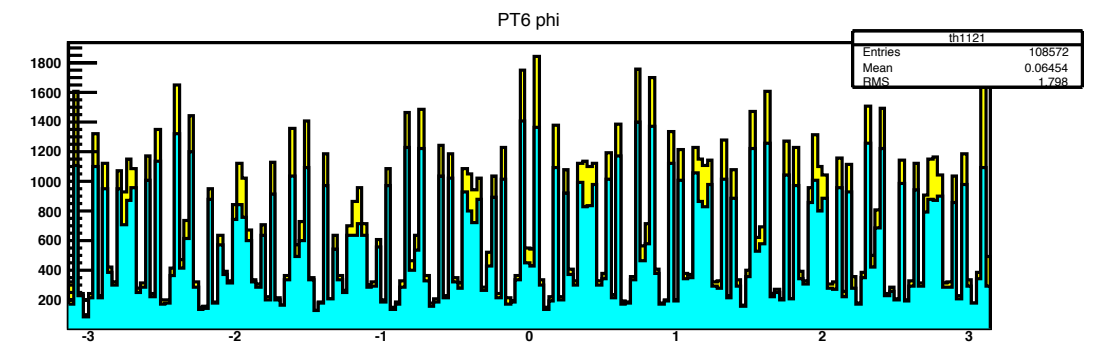
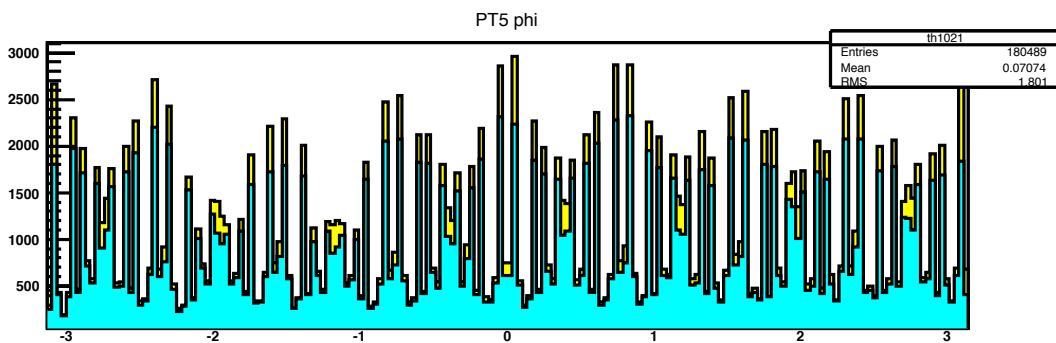
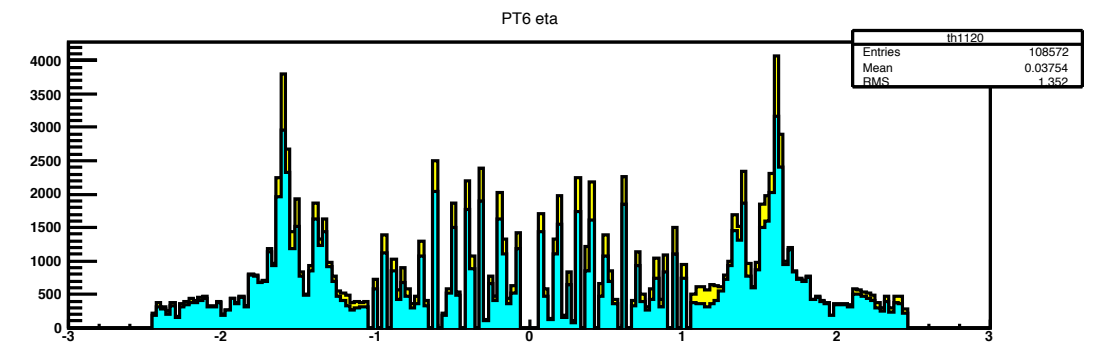
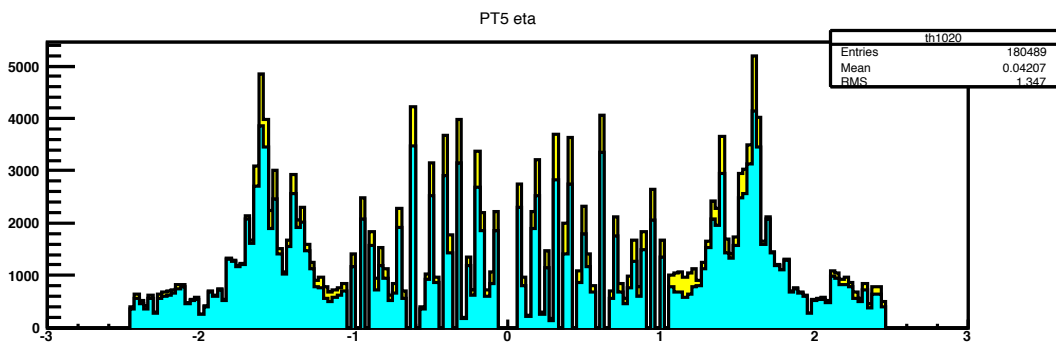
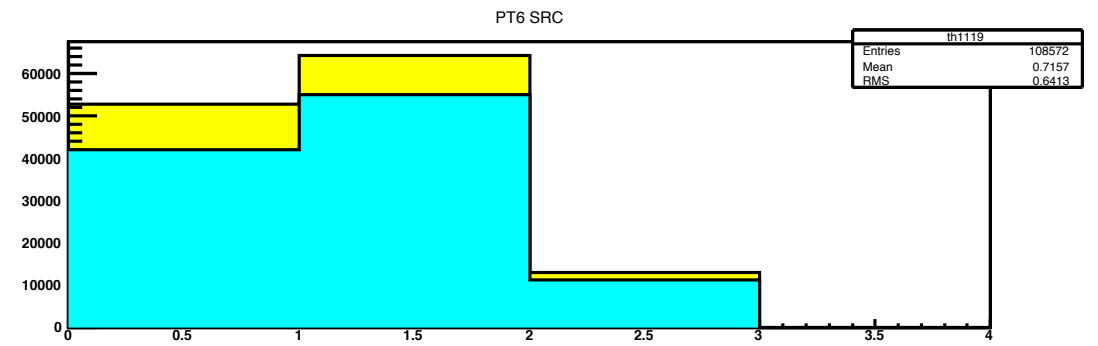
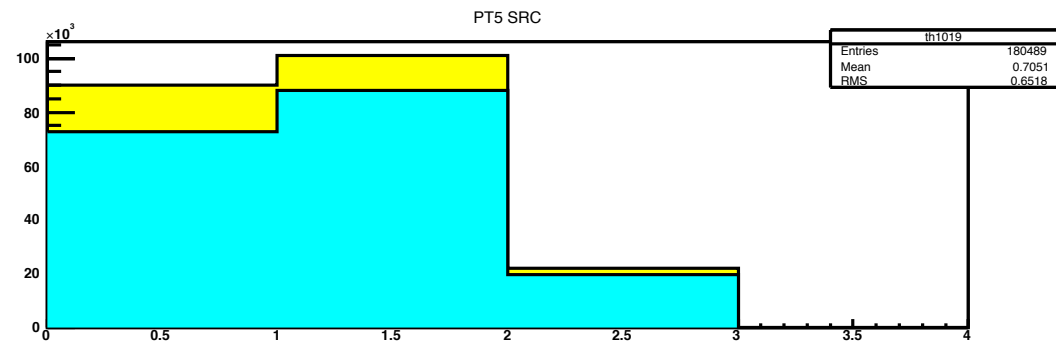
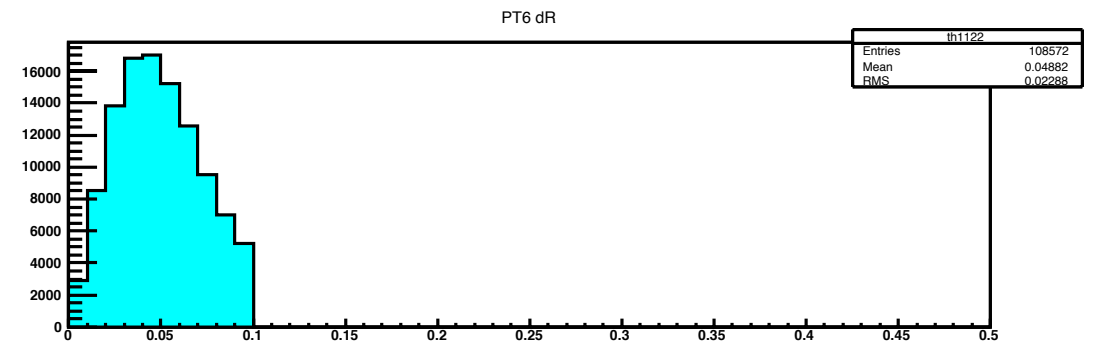
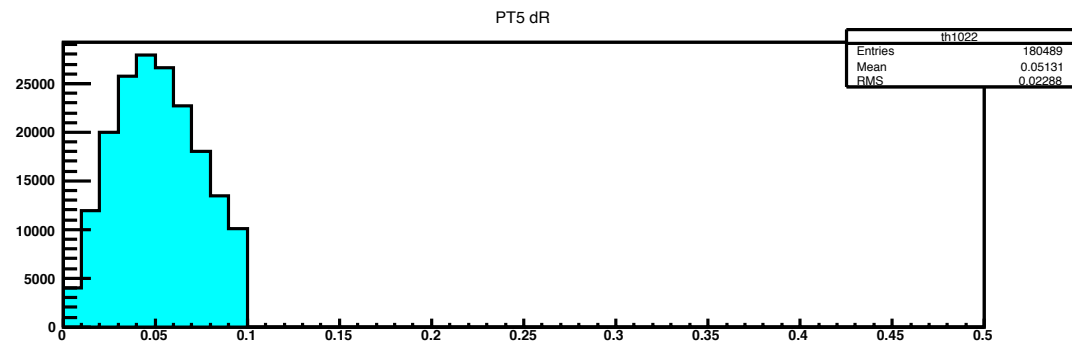
S4:pT5



S4:pT6



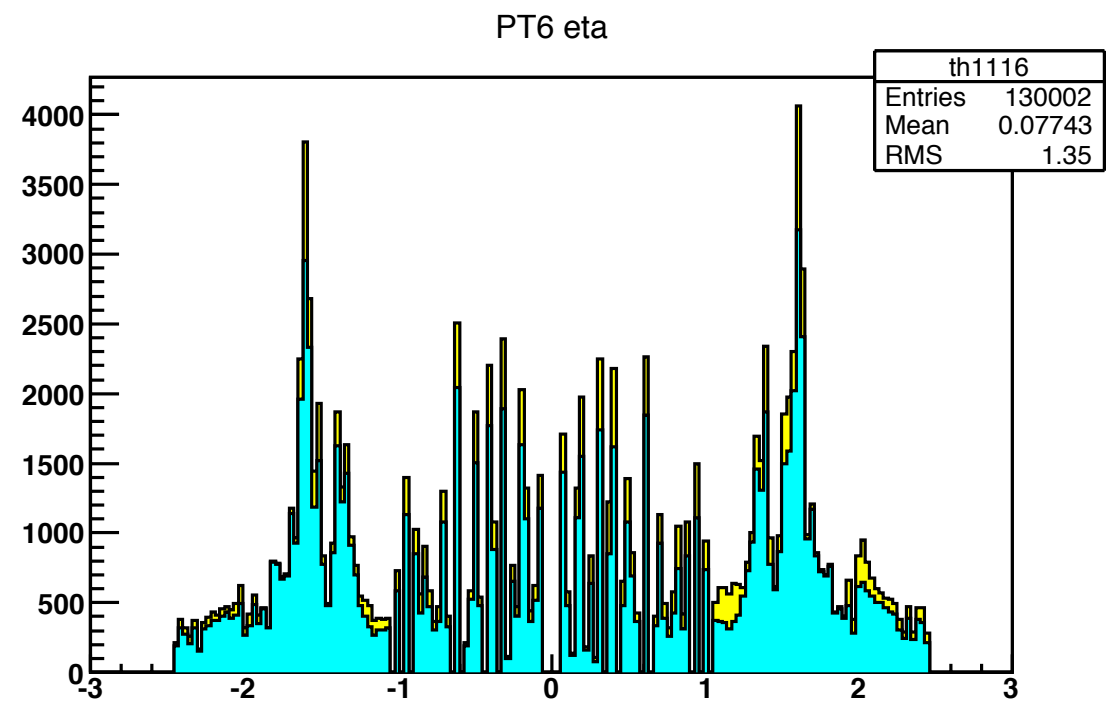
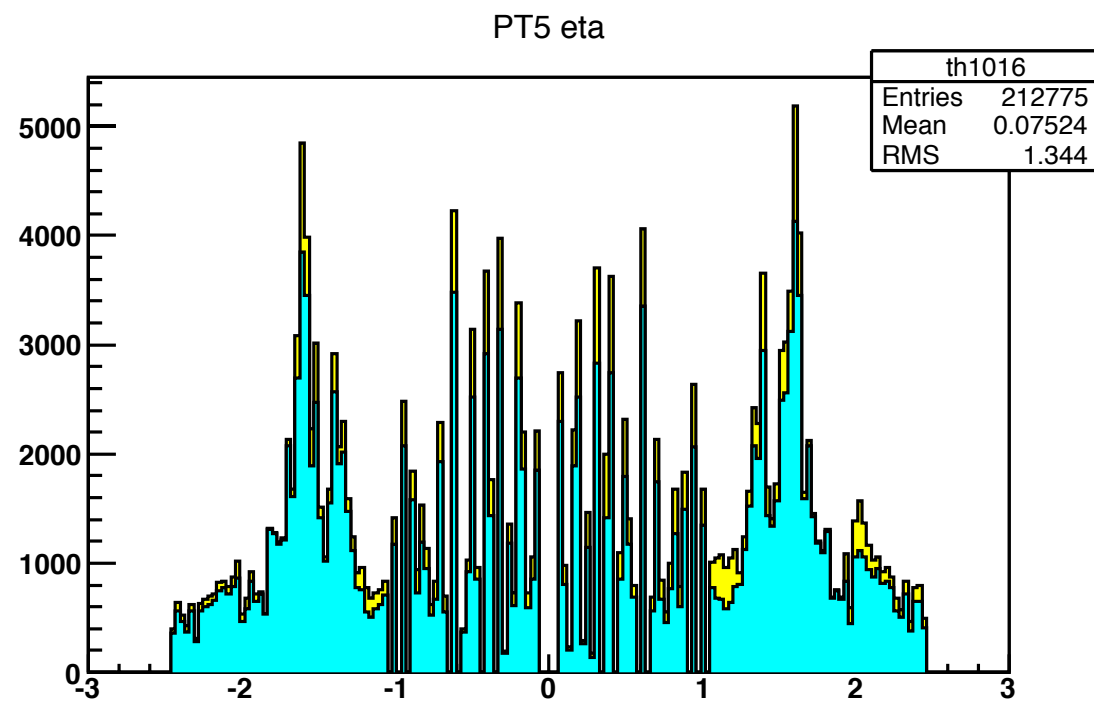
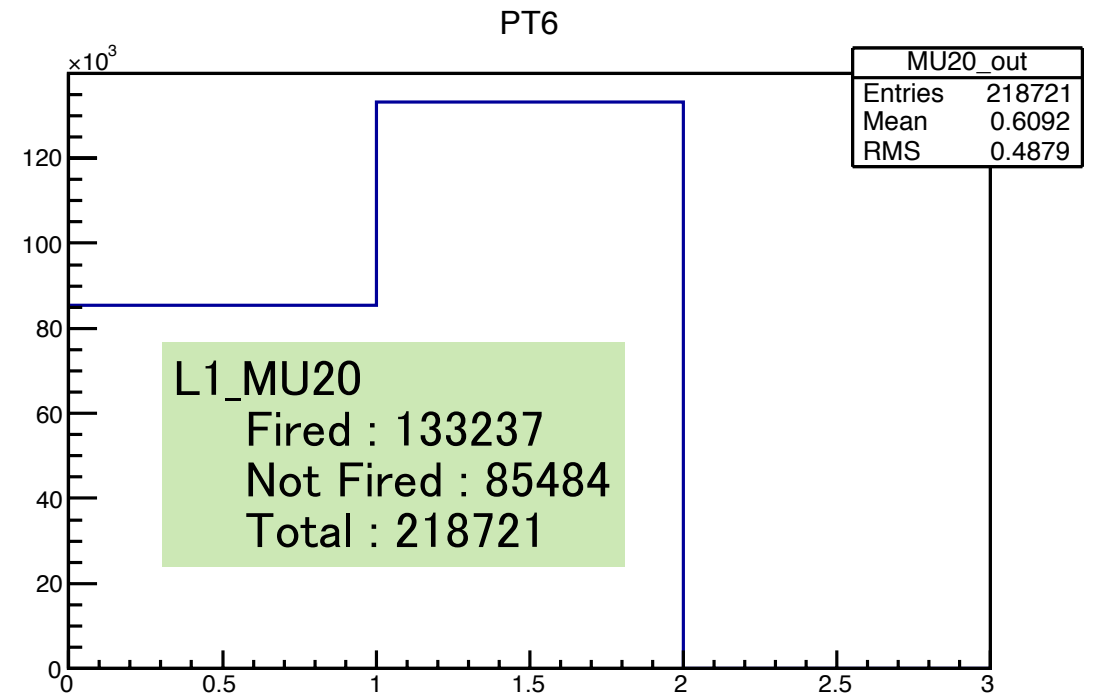
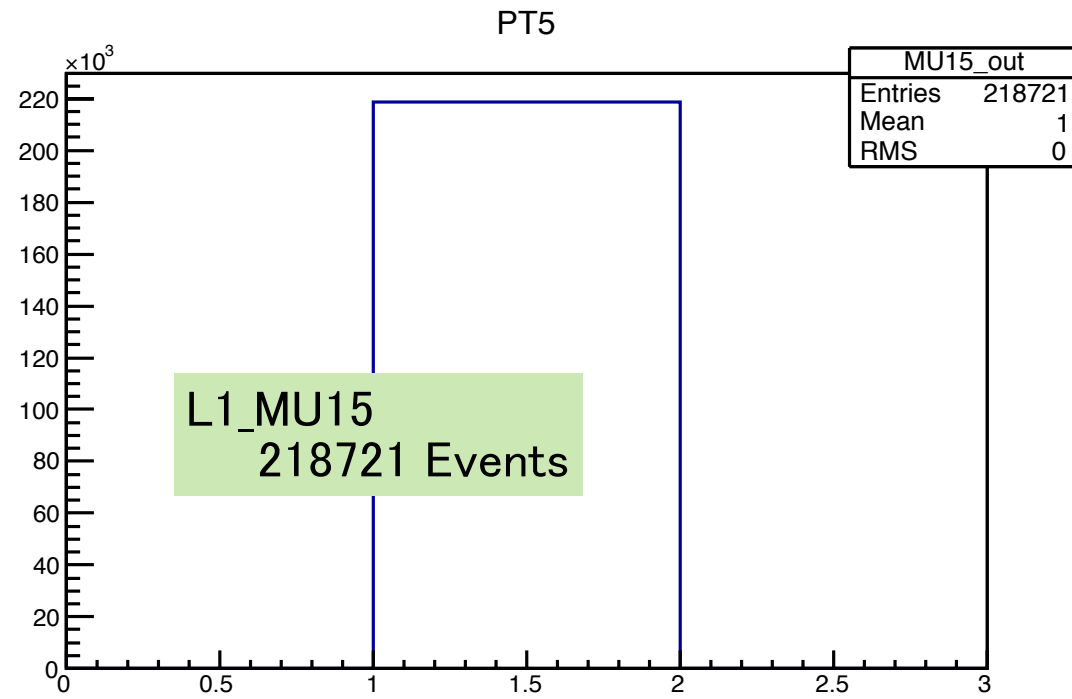
S4:黄色 青 重ね書き



Correction後 (S4')

(MDT – CSC間の隙間でのinefficiencyの補正)

trigger数変化



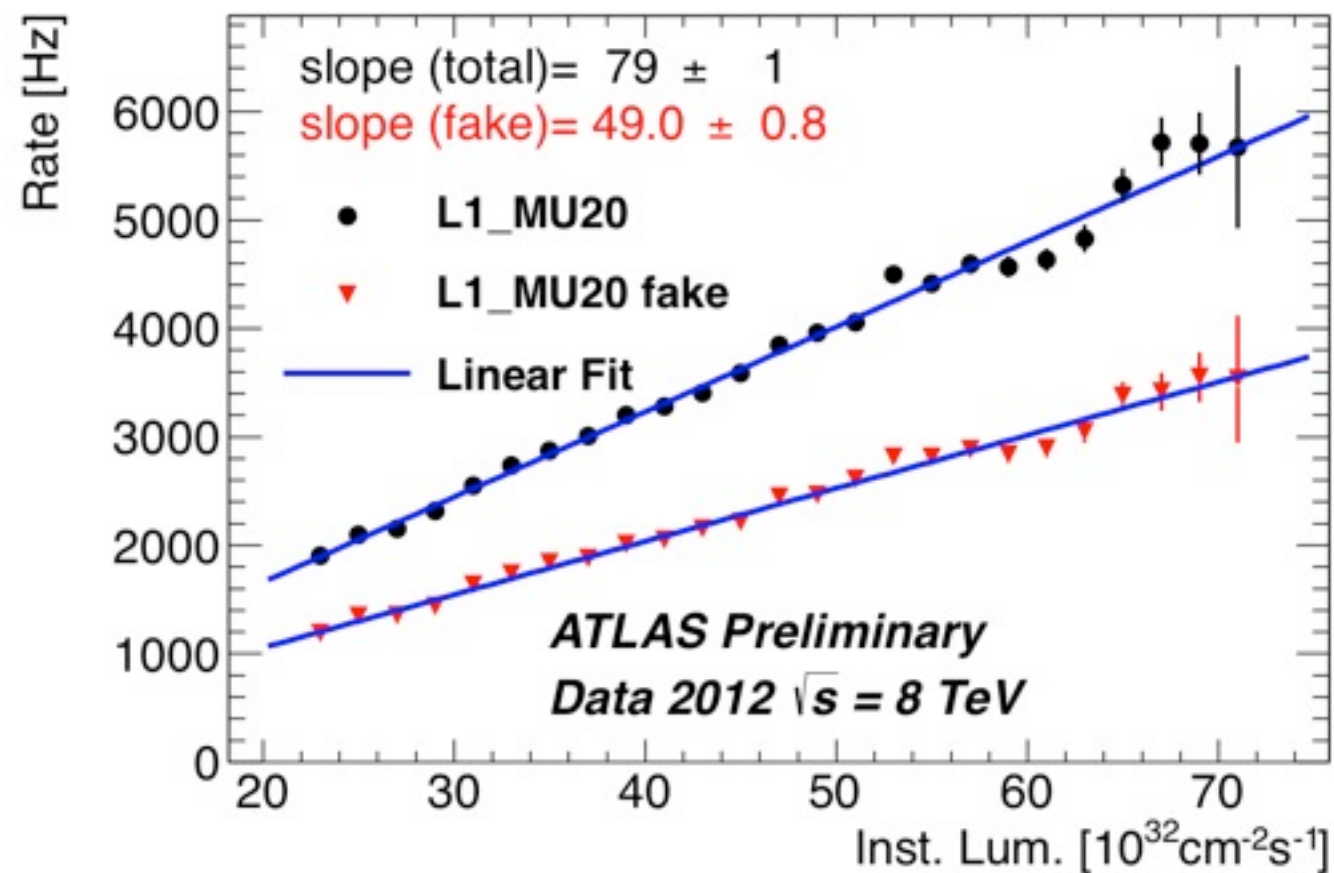
trigger数 推移 (pT5)

	all RoI		1 fill/event		w staco(dR<0.1)	
S1 (before EI/FI cut)	867548		847765		265457	
	91596 (RPC)	775952 (TGC)	88138(RPC)	759627(TGC)	71224(RPC)	194233 (TGC)
S2 (EI/FI cut)	548205		535329		247223	
	91596 (RPC)	456609 (TGC)	90189 (RPC)	445140 (TGC)	72926 (RPC)	174297 (TGC)
S3 (Tile Cut)	502024		489571		245470	
	91306 (RPC)	410718 (TGC)	89929 (RPC)	399642 (TGC)	72740 (RPC)	172730 (TGC)
S4 (NSW Cut)	218513		212761		180489	
	91306 (RPC)	127207 (TGC)	89991 (RPC)	122770 (TGC)	72795 (RPC)	107694 (TGC)
S4' (Correction)	—		218721		184309	
	—	—	89991 (RPC)	128730 (TGC)	72795 (RPC)	111514 (TGC)

trigger数 推移 (pT6)

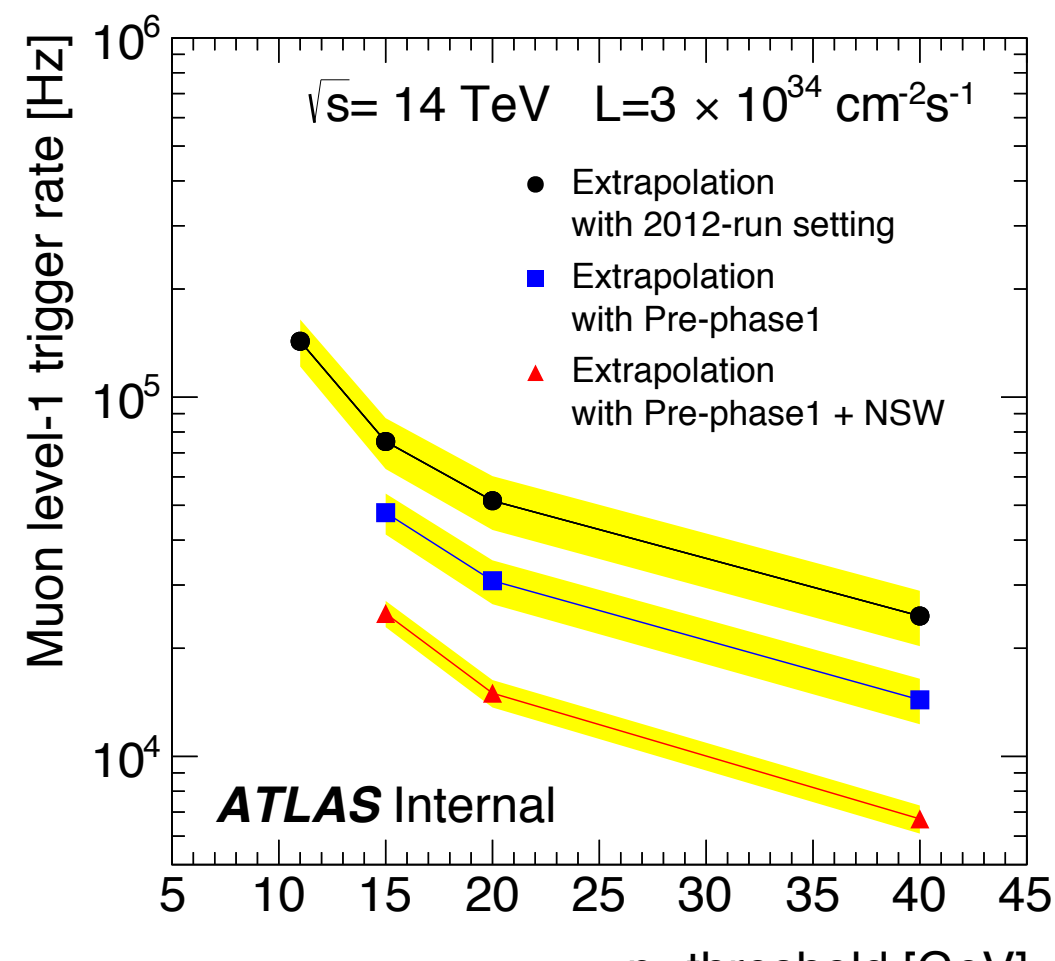
	all RoI		1 fill/event		w staco(dR<0.1)	
S1 (before EI/FI cut)	609212		595890		157250	
	53748 (RPC)	555464 (TGC)	51591 (RPC)	544299 (TGC)	41145 (RPC)	116105 (TGC)
S2 (EI/FI cut)	367525		359085		145138	
	53748 (RPC)	313777 (TGC)	52915 (RPC)	306170 (TGC)	42245 (RPC)	102893 (TGC)
S3 (Tile Cut)	334158		326009		144113	
	53562 (RPC)	280596 (TGC)	52748 (RPC)	273261 (TGC)	42130 (RPC)	101983 (TGC)
S4 (NSW Cut)	133794		129988		108572	
	53562 (RPC)	80232 (TGC)	52775 (RPC)	77213 (TGC)	42152 (RPC)	66420 (TGC)
S4' (Correction)	—		133237		110325	
	—	—	52775 (RPC)	80462 (TGC)	42152 (RPC)	68173 (TGC)

trigger rate



public result より、
 8 TeV, 50 ns, $1 \text{ e}34 \text{ cm}^{-2} \text{ s}^{-1}$ で
 MU20 trigger rate : $\sim 8 \text{ kHz}$

8 TeV, 25 ns, $1 \text{ e}34 \text{ cm}^{-2} \text{ s}^{-1}$ で
 MU20 trigger rate : $\sim 11.2 \text{ kHz}$



Back up

MU15, MU20削減

トリガーレート見積もりの手順

- Step1. : L1_MU15がひとつ以上含まれるイベントでskim
- Step2. : TGC EI/FI cutでskim
 - Step2-0 : EI/FI cut条件($d\eta$, $d\phi$)の決定 ← Done
 - Step2-1 : EI/FI cutを用いるSSCの決定 ← Ongoing on grid
 - Step2-2 : Step2-0, 2-1 で決定した条件の下、実際にskim
- Step3. : Tile cutでskim
- Step4. : NSW cutでskim

EI/FI Cut条件

前回(先週)までのcoincidence条件

- ・ SLに入力される8 つのEI/FI chamberのどれかで wire-strip AND がとれたらtrigger発行

新しい coincidence条件

- ・ BW でのhit位置とEI/FIでのhit位置の間の $d\eta$, $d\Phi$ が $|d\eta| < d\eta_{\text{threshold}}$ AND $|d\Phi| < d\Phi_{\text{threshold}}$ を満たす時、triggerを発行
 - $d\eta = (\text{SSCの}\eta\text{の中心値}) - (\text{hitがあったEI/FIのwire 8channelの}\eta\text{の中心値})$
 - $d\Phi = (\text{SSCの}\Phi\text{の中心値}) - (\text{hitがあったEI/FIのstrip 8channelの}\Phi\text{の中心値})$

要求するEI/FI channel : SSC単位で決める

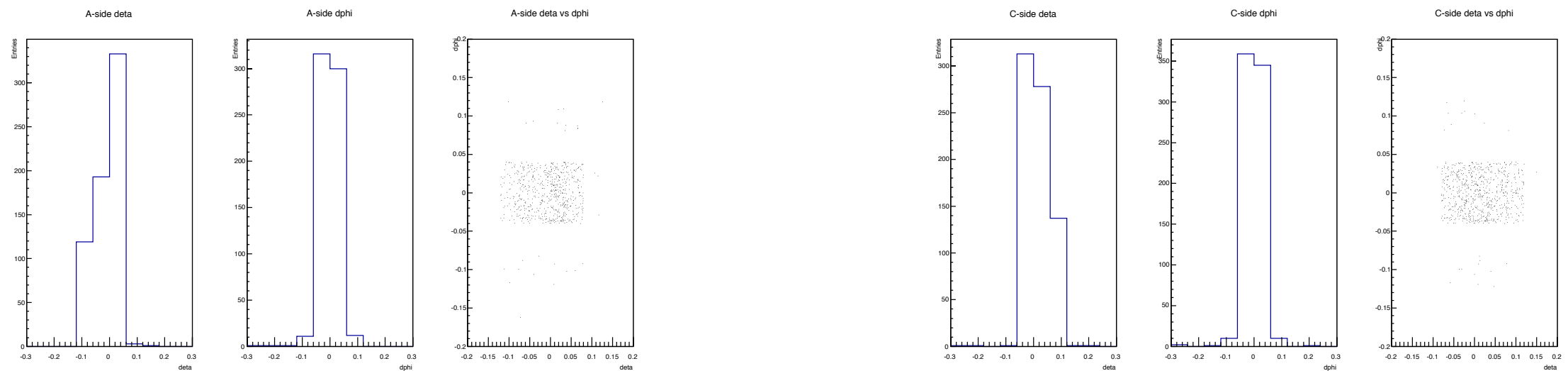
SLに入力されるEI/FI 信号 : wire 8channelのOR, strip 8channelのOR

現実に実装されるものに近いcoincidence条件となる

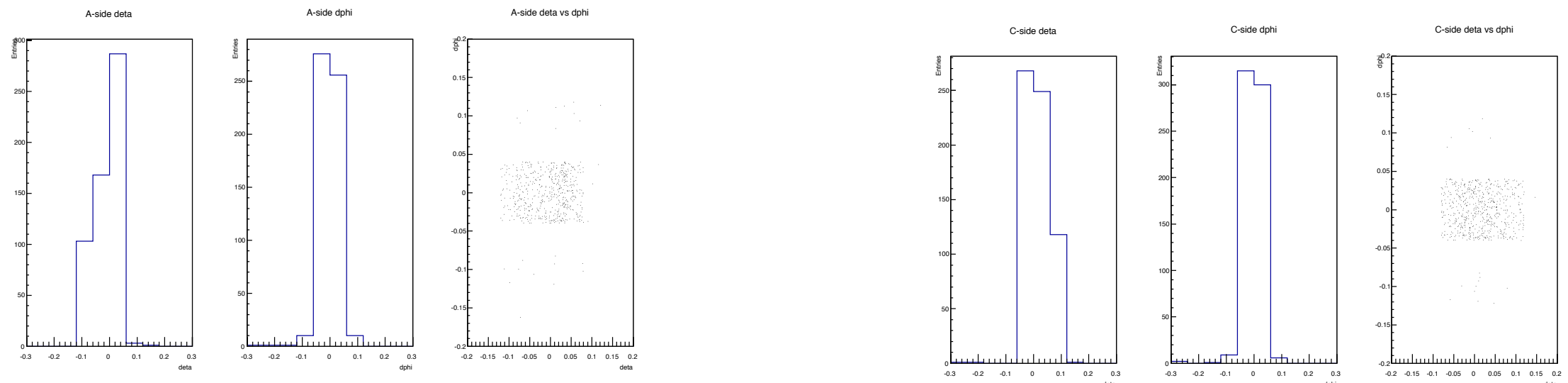
$d\eta$ threshold, $d\Phi$ threshold 決定

high- p_T staco muonを伴ったeventに対し、最小の $d\eta$, $d\Phi$ 分布をplot
- RoI の η が $1.3 < |\eta| < 1.9$ となる領域のみ

offline $p_T > 15$ GeVを伴い、L1_MU15が発行されたEvent



offline $p_T > 20$ GeVを伴い、L1_MU20が発行されたEvent



cut条件として $d\eta$ threshold = 0.15, $d\Phi$ threshold = 0.05 を設定

各SSCでのefficiency

EI/FIに覆われていない領域ではEI/FI cut によってtrigger efficiencyが下がる

→ efficiencyが下がる領域ではEI/FI coincidenceを要求しない

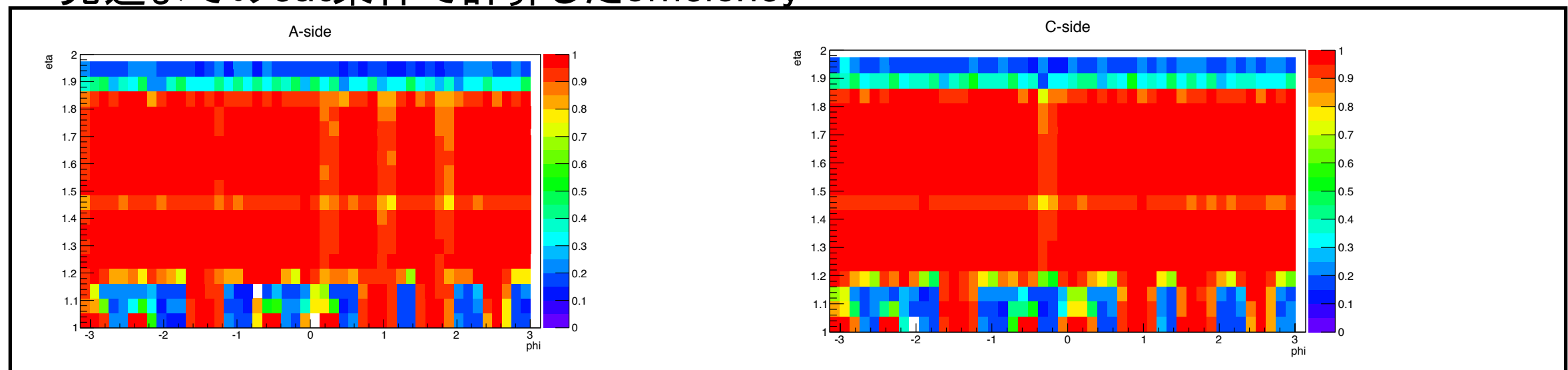
– offline $p_T > 20$ GeV のstaco ($dR < 0.1$) を伴ったeventに対するefficiencyを計算

– coincidenceを要求する領域はSSC単位で決定する

* 実際のSLではcoincidenceを要求する領域はRoI単位で決定する

* が、今回は時間がないのでSSC単位で妥協する

先週までのcut条件で計算したefficiency

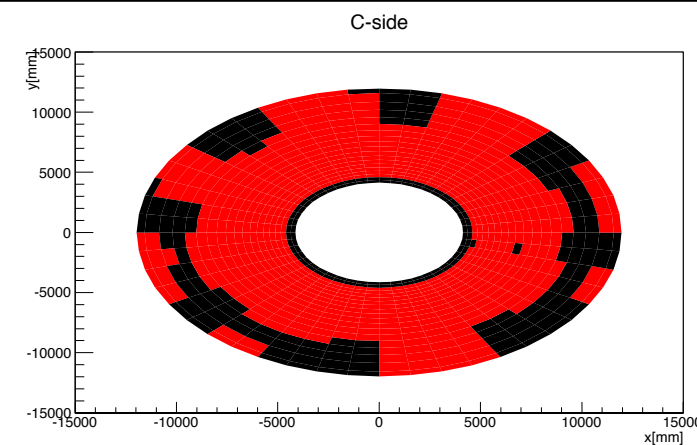
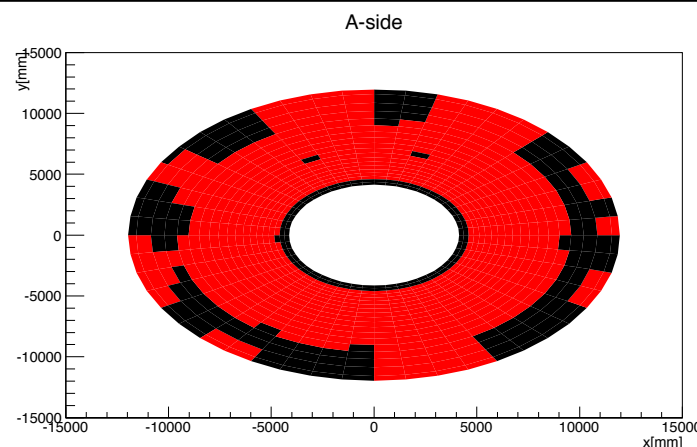
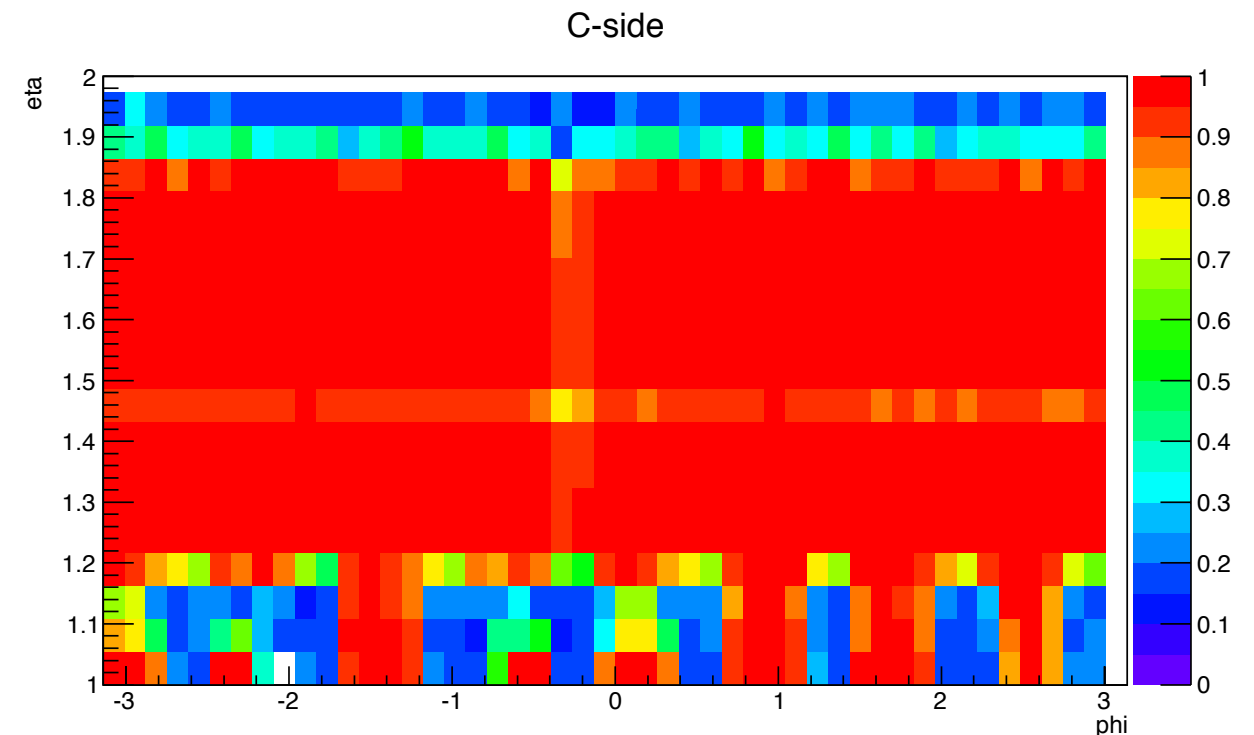
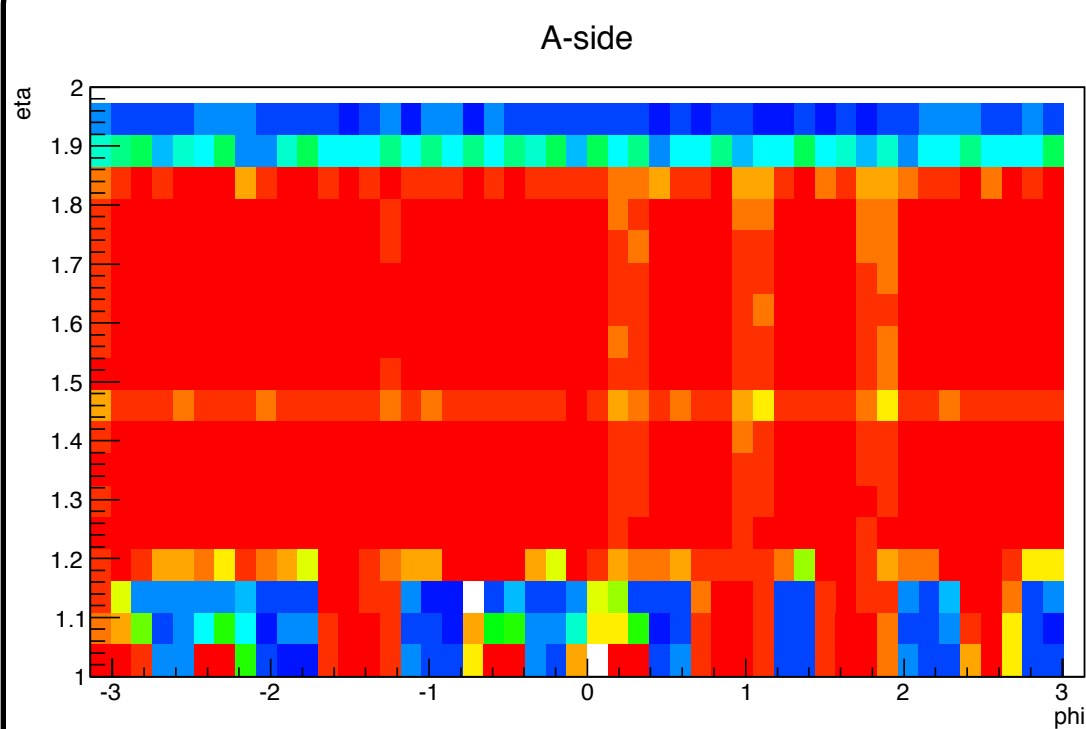


現在、50 ns runのデータを用いて grid上でefficiencyを計算中
これが終わり次第、25 ns runに対して実際にcutをかける

SSC efficiency

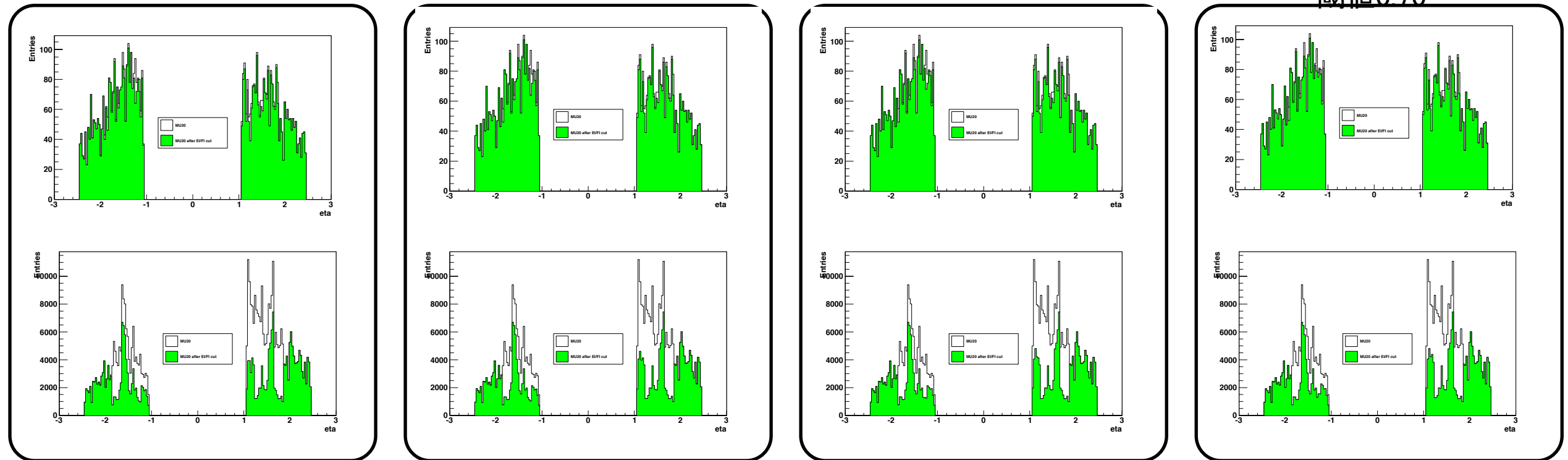
- EI/FI cut : SSC毎にBW-EI/FI coincidenceをcutに用いるかどうかを設定
 - $pT > 20$ GeVに対するefficiencyが閾値以上のSSCでのみcutに用いる
 - 先週まで : 閾値は0.8 で固定

各SSC でのefficiency

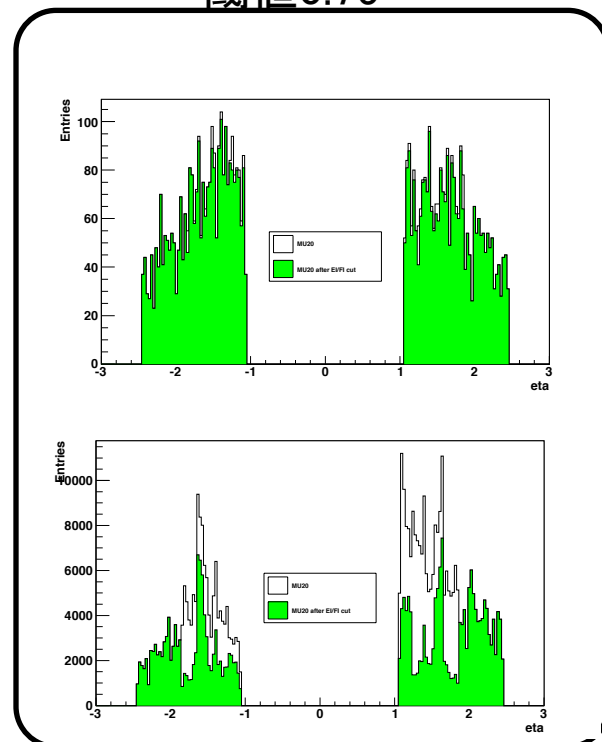


SSC efficiency

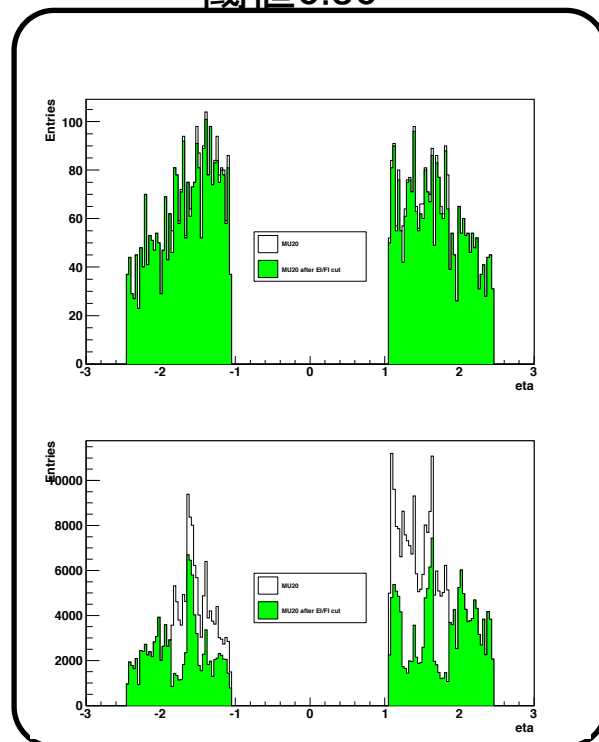
閾値0.70



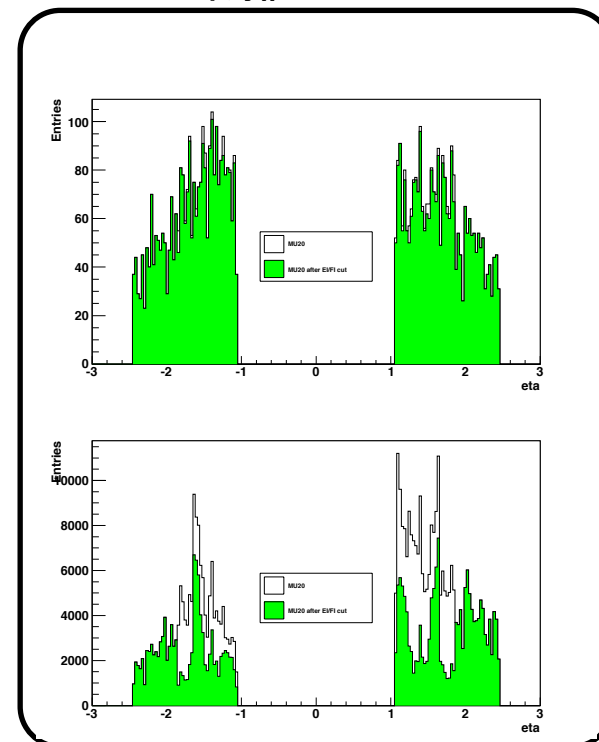
閾値0.75



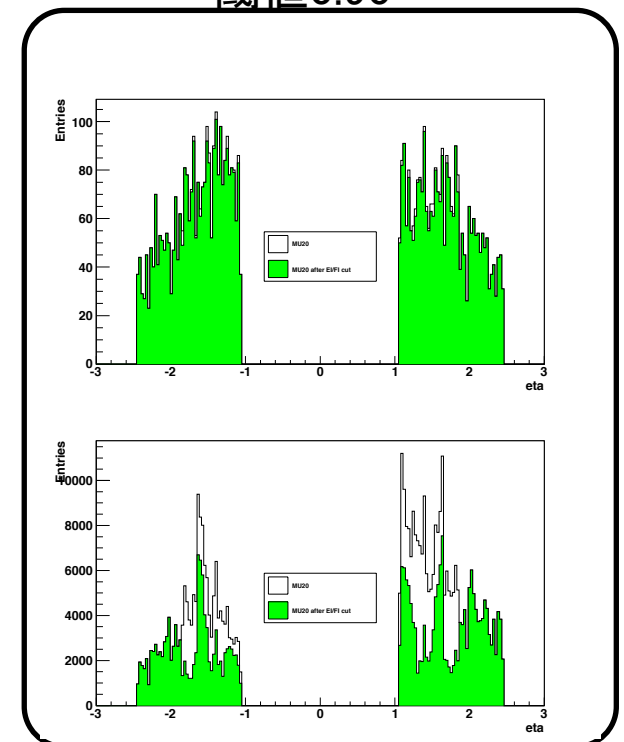
閾値0.80



閾値0.85

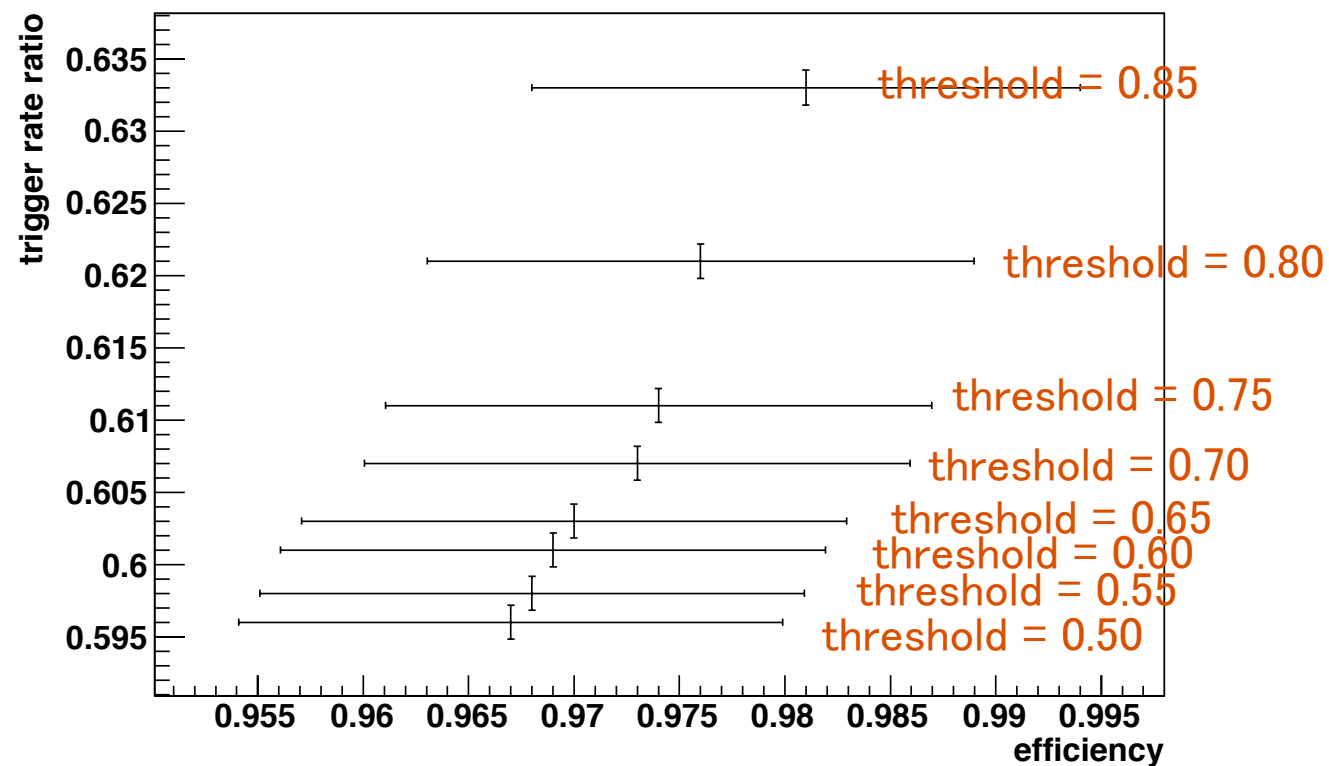


閾値0.90



閾値の決定

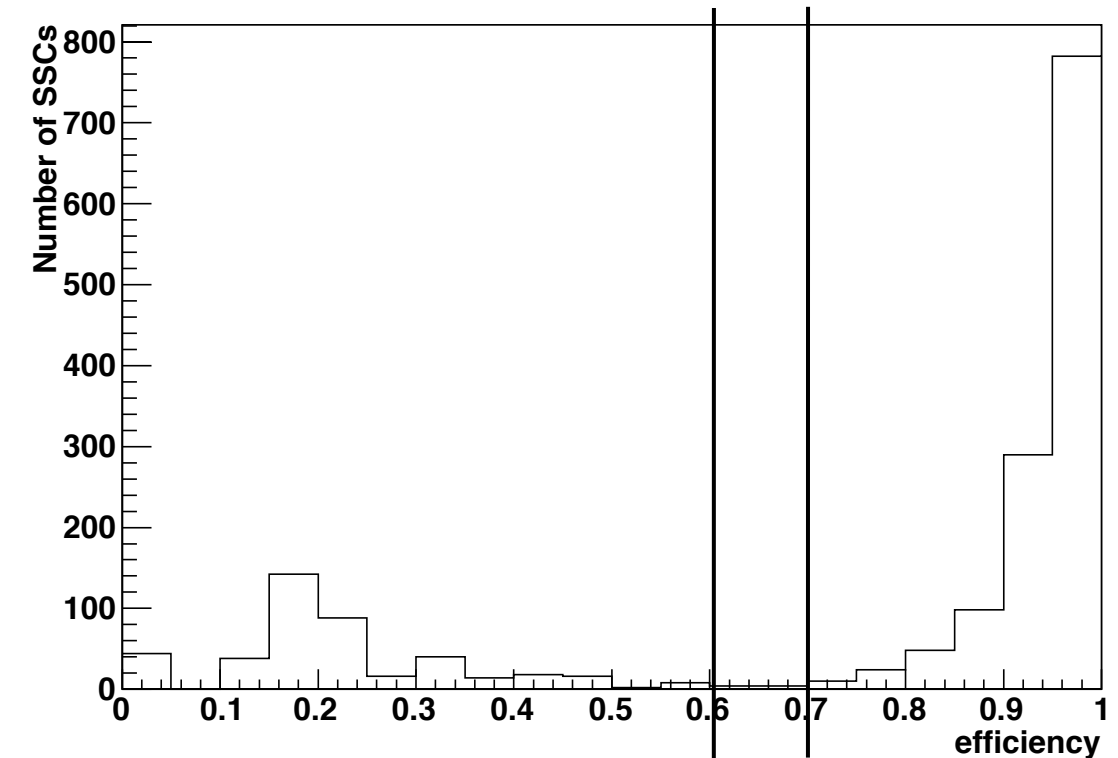
efficiency v.s. trigger rate の2次元plot



$$\text{efficiency} = \frac{\text{offline } pT > 20 \text{ GeV を伴うMU20数(cut後)}}{\text{offline } pT > 20 \text{ GeV を伴うMU20数(cut前)}}$$

$$\text{trigger rate ratio} = \frac{\text{MU20数(cut後)}}{\text{MU20数(cut前)}}$$

SSCのefficiency分布



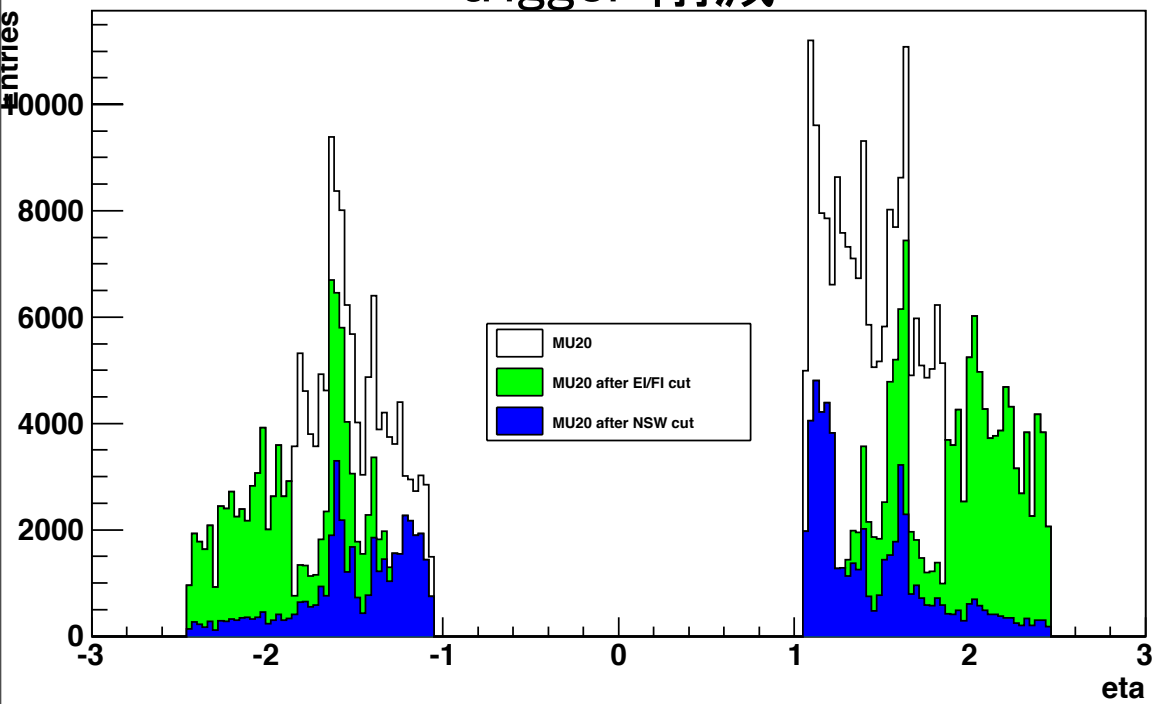
efficiency閾値としては0.6 ~ 0.7 あたりが妥当

今回はefficiency閾値として0.7 を採用する

result

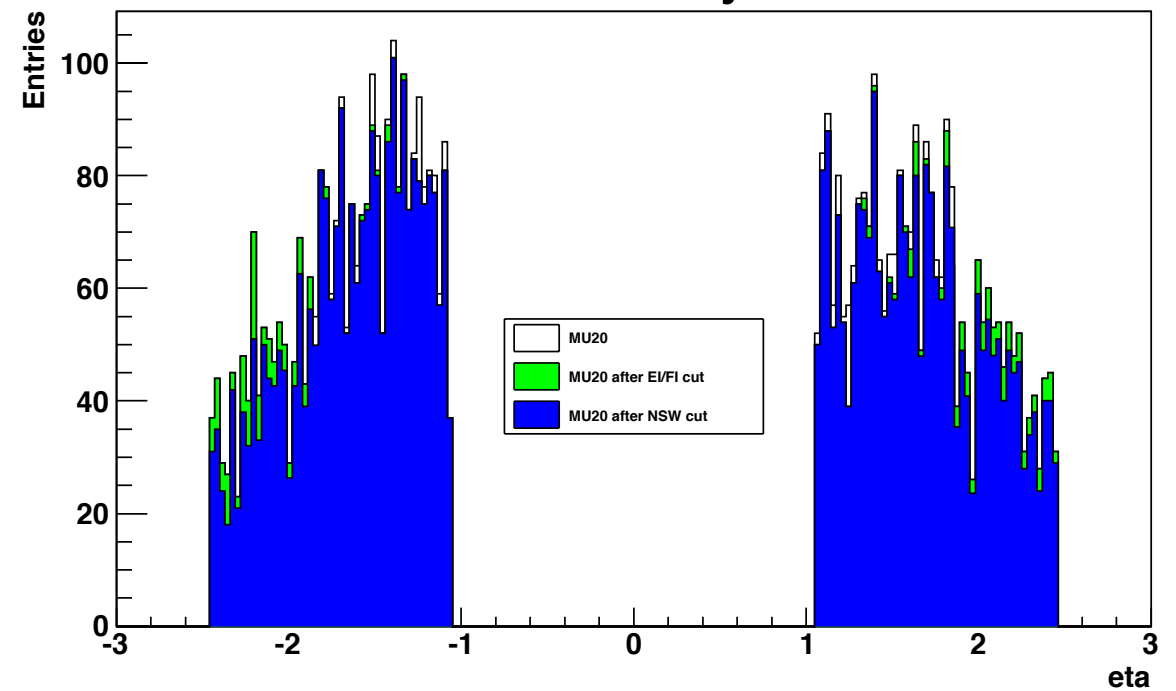
efficiency閾値 **0.7** を採用して、

trigger 削減



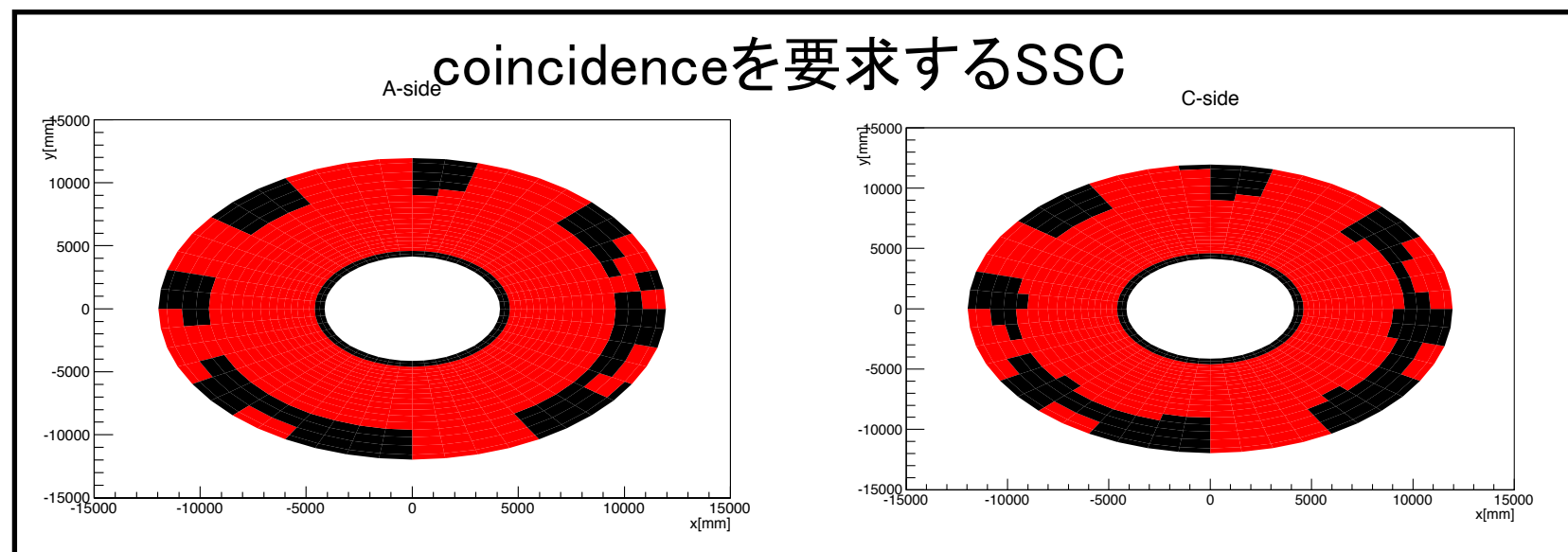
EI/FI cut : **39.3 %** 削減
EI/FI + NSW cut : **77.5 %** 削減

efficiency



EI/FI cut : **2.6 %** loss
EI/FI + NSW cut : **6.9 %** loss

coincidenceを要求するSSC



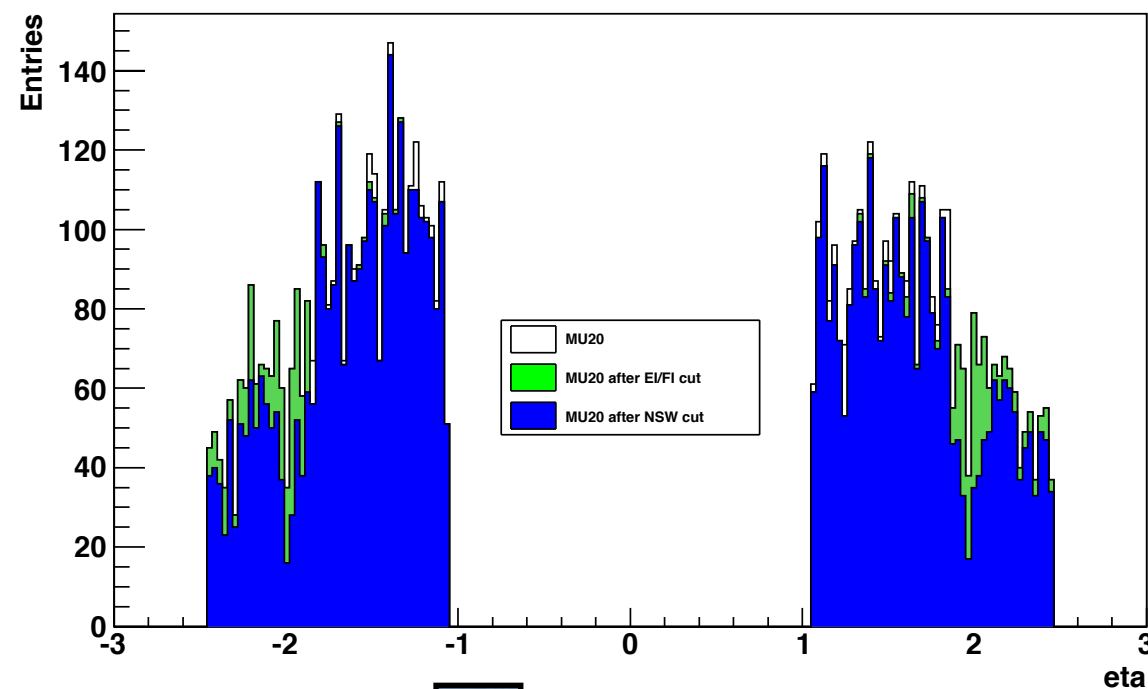
Coincidence条件

- ・ EI/FI cut : SLに入力されるEI/FI chamberのうちどれかでwire-strip coincidenceがとれる
(* ただし、このcutによりefficiencyが従来の80 %以下になる領域では、coincidenceを要求しない)
- ・ NSW cut : $d\theta$, $d\eta$, $d\phi$ を独立に用いてcut
具体的なcut条件は、鈴木友さんのstudyと同じものを用いた

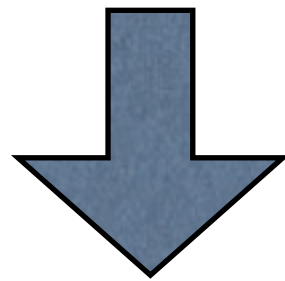
NSW cut条件			
$ \eta $	$d\theta$	$d\eta$	$d\phi$
1.3 - 1.5	0.015	0.05	0.06
1.5 - 1.7	0.015	0.05	0.06
1.7 - 1.9	0.010	0.05	0.06
1.9 - 2.1	0.025	0.05	0.06
2.1 - 2.3	0.07	0.07	0.06
2.3 -	0.07	0.07	0.06

MDTのない領域への対応

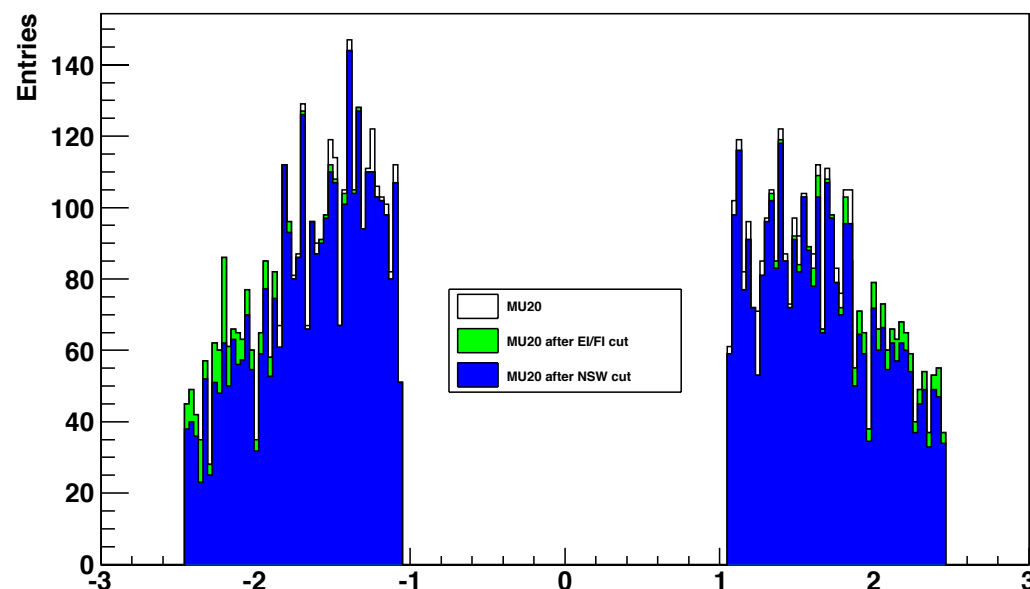
combined muon を伴ったL1_MU20
(offline $p_T > 20$ GeV)



現在のstudyでは、 $|\eta|=2$ 付近でNSW cutの efficiencyが悪い。
現在はNSWの代用としてMDT, CSCの情報を用いている。
 $|\eta|=2$ 付近はMDTとCSCの境界のため、trackが得られず efficiencyが低くなっている。



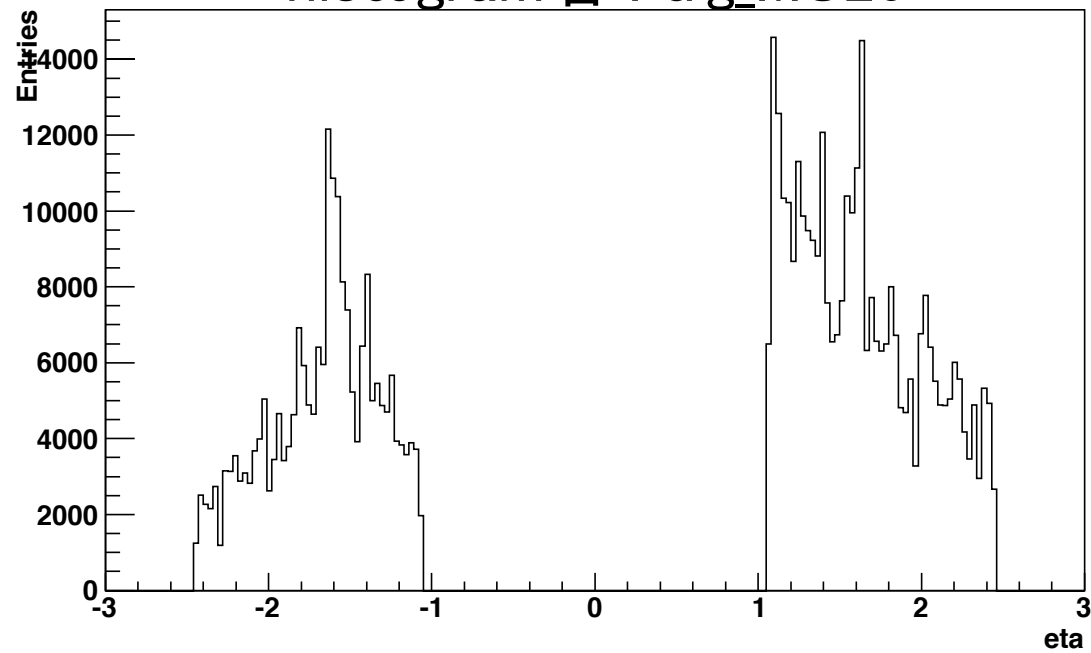
Correction



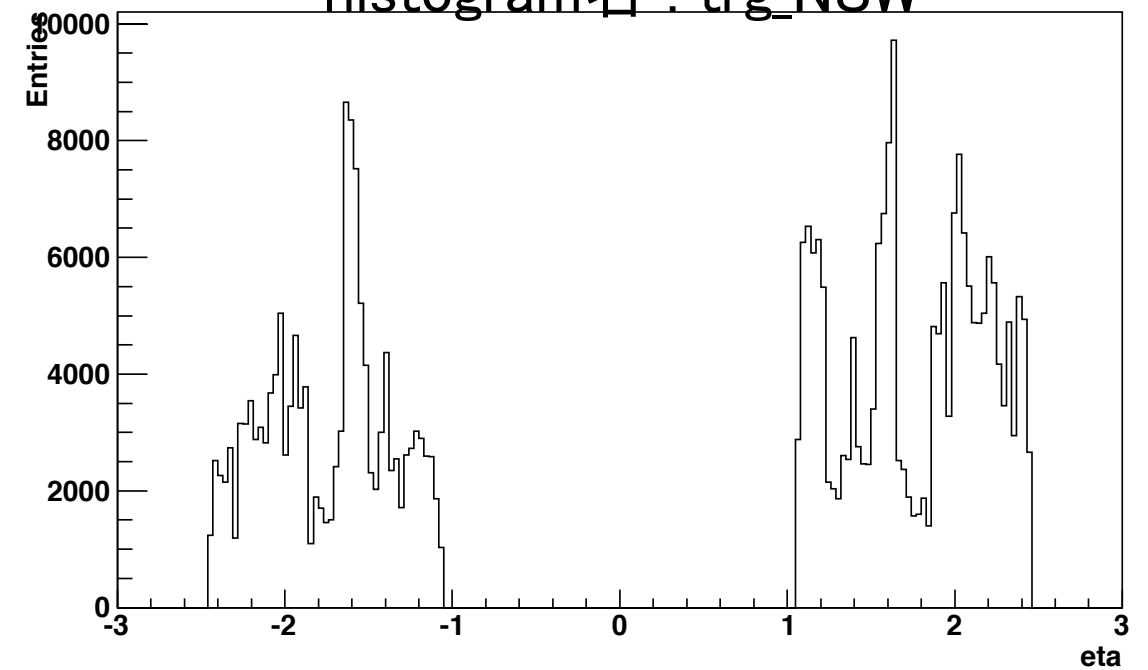
$1.8 < |\eta| < 2.1$ の領域のレート削減、efficiencyが
周りの領域($1.7 < |\eta| < 1.8$, $2.1 < |\eta| < 2.4$)と等しくなることを仮定し、計算し直した

MU20 削減

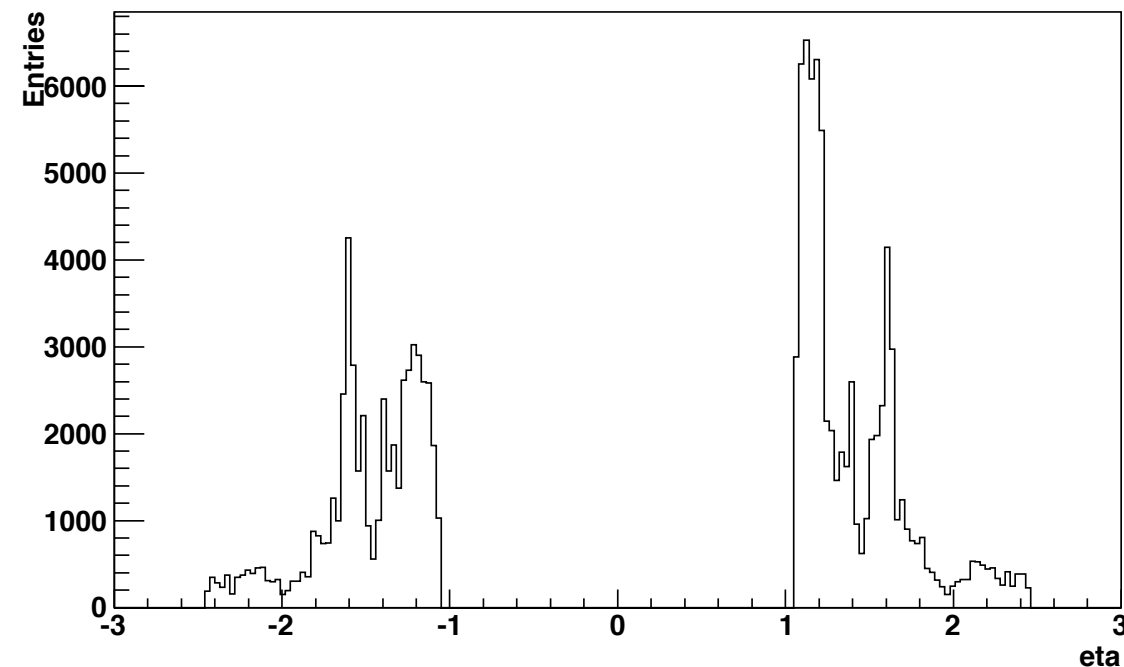
現在のL1_MU20 η 分布
histogram名 : trg_MU20



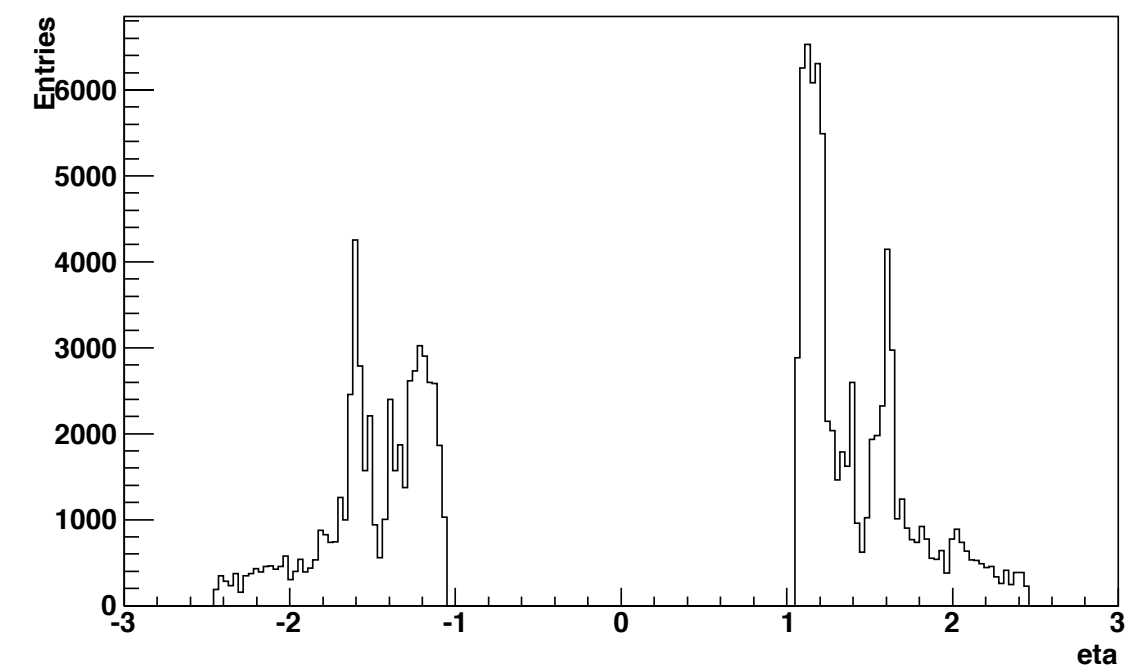
L1_MU20 η 分布 EI/FI cut後
histogram名 : trg_NSW



L1_MU20 η 分布 EI/FI + NSW cut後
histogram名 : trg_NSW

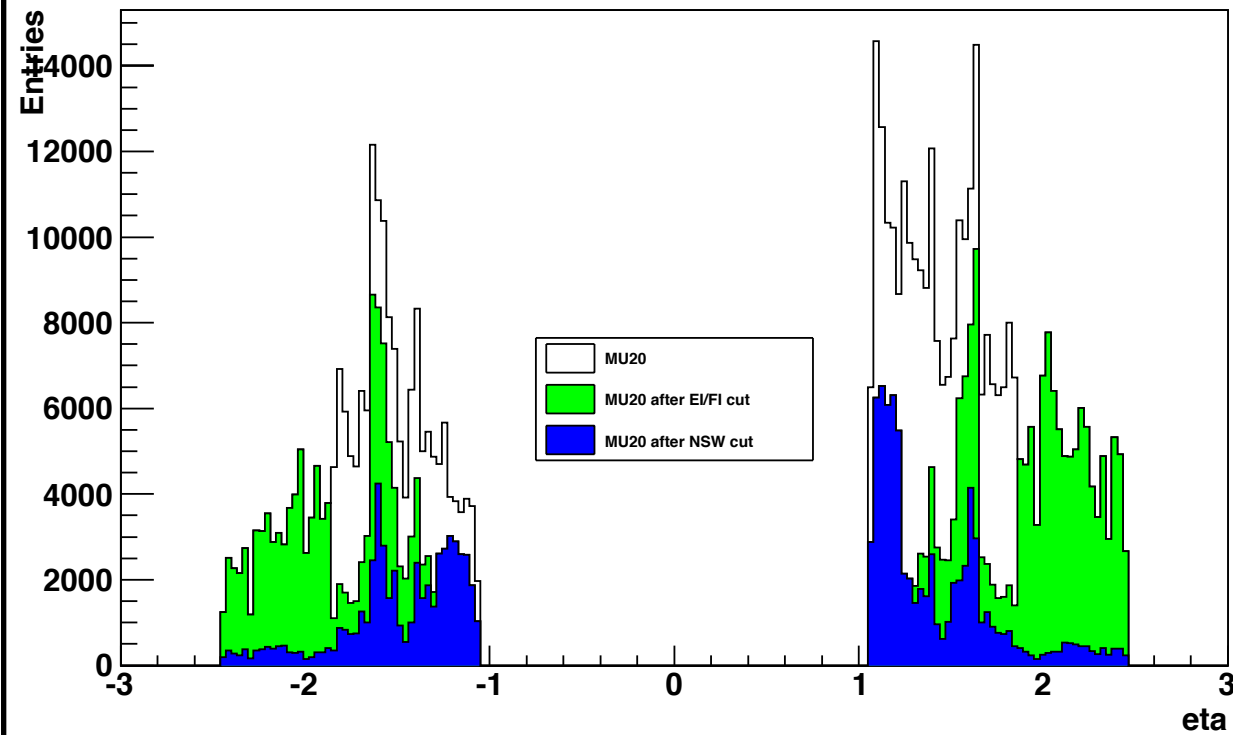


L1_MU20 η 分布 correction後
histogram名 : trg_Correction



MU20 削減

Correctionなし



trigger数

MU20 : 566024

EI/FI cut
38 % 削減

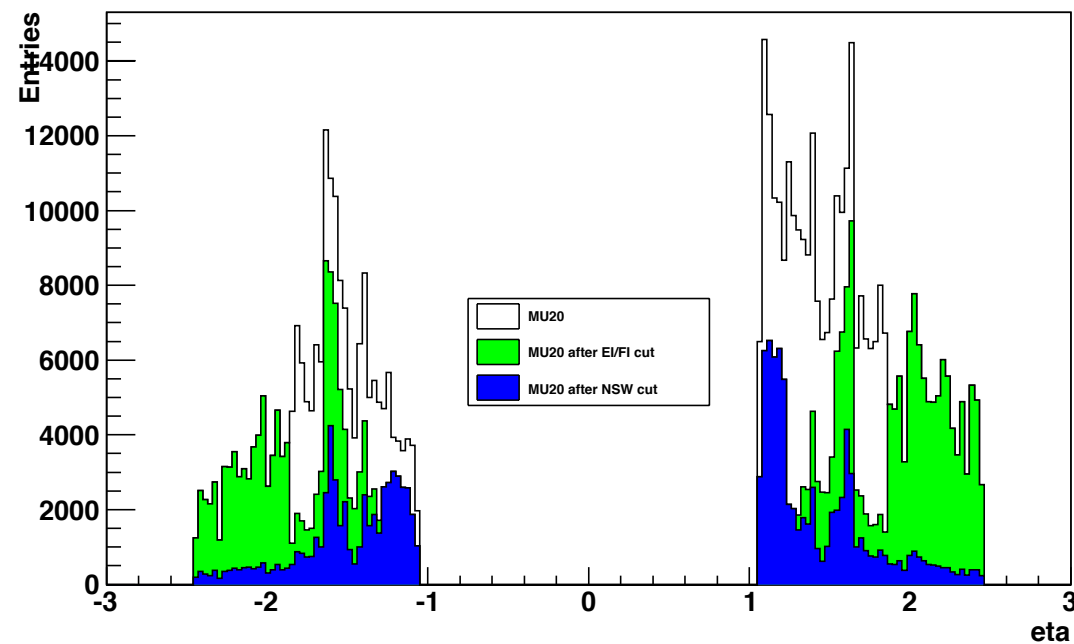
349965

NSW cut
63 % 削減

128513

77 % 削減

Correctionあり



trigger数

MU20 : 566024

EI/FI cut
38 % 削減

349965

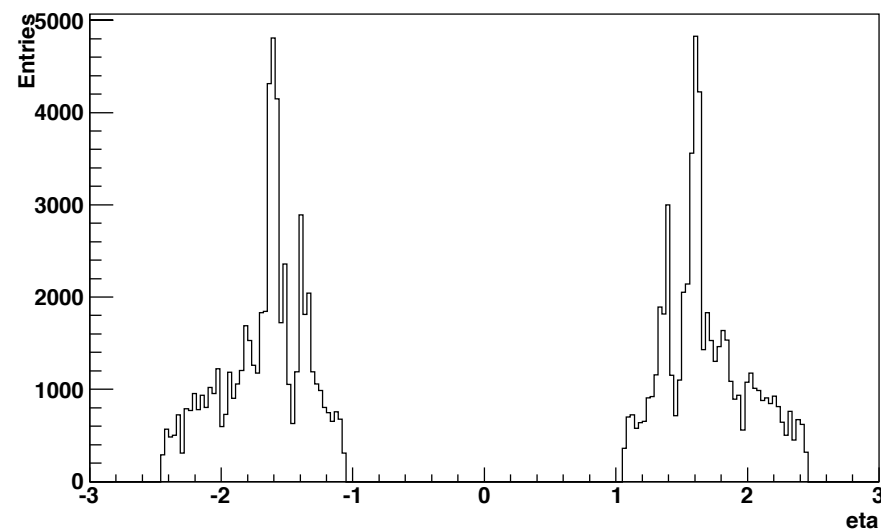
NSW cut
62 % 削減

133198

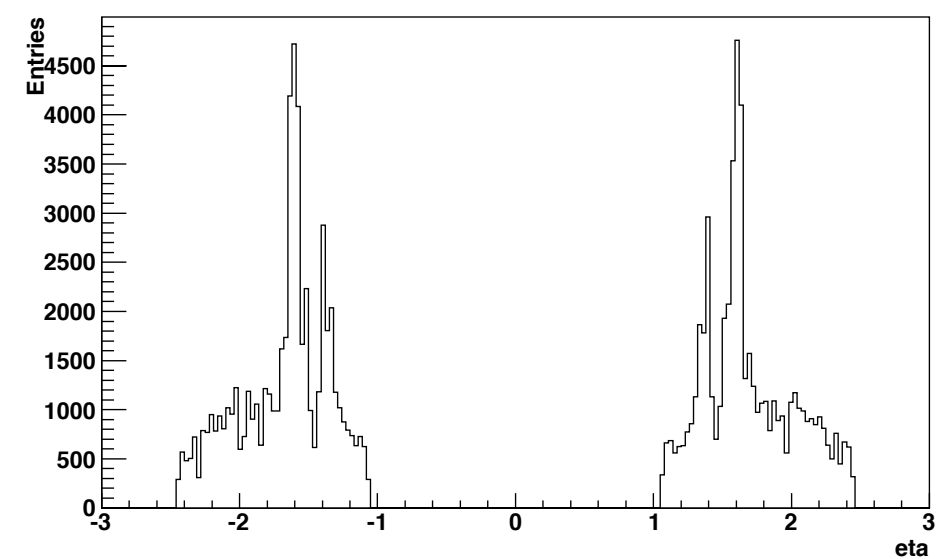
77 % 削減

combined muonを伴ったMU20

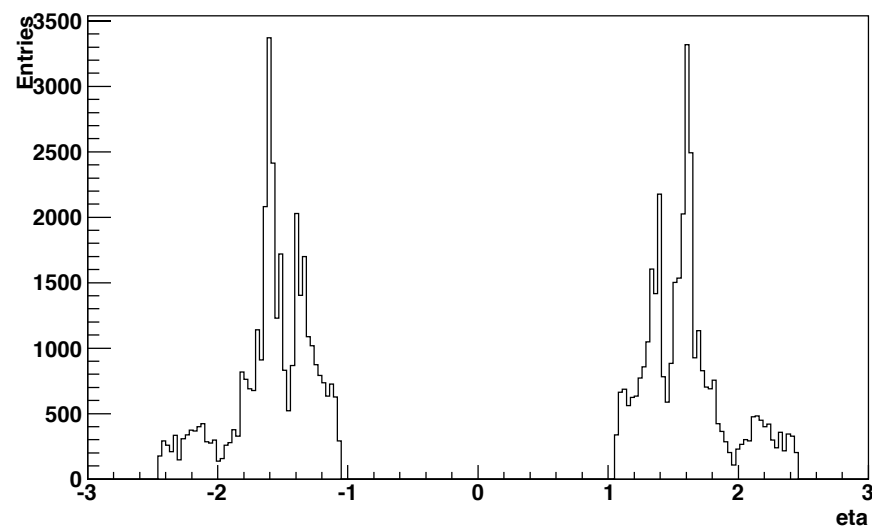
現在のL1_MU20 η 分布
histogram名 : Muon_MU20



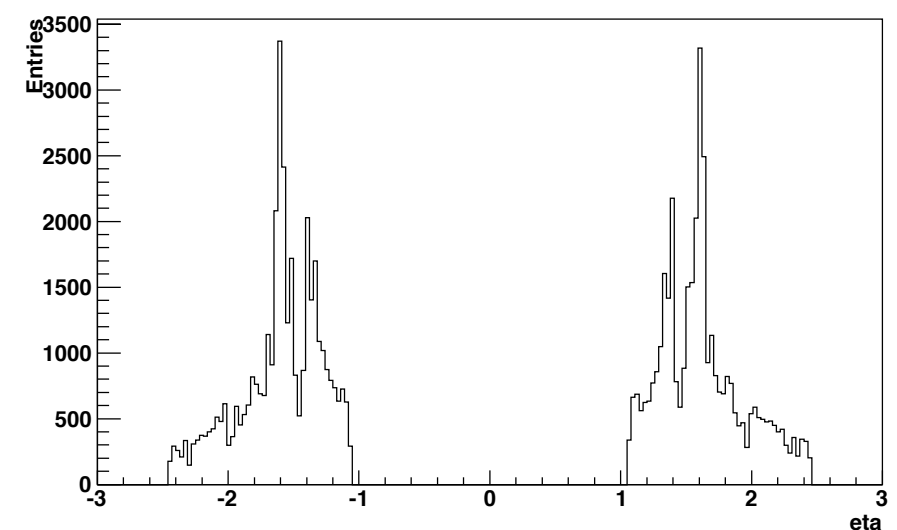
L1_MU20 η 分布 EI/FI cut後
histogram名 : Muon{EIFI



L1_MU20 η 分布 EI/FI + NSW cut後
histogram名 : Muon_NSW

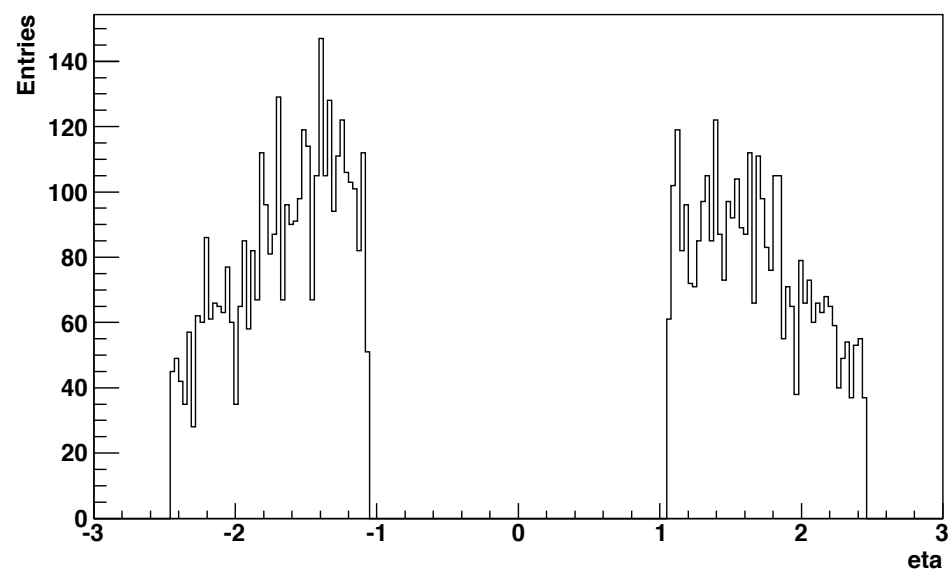


L1_MU20 η 分布 correction後
histogram名 : Muon_Correction

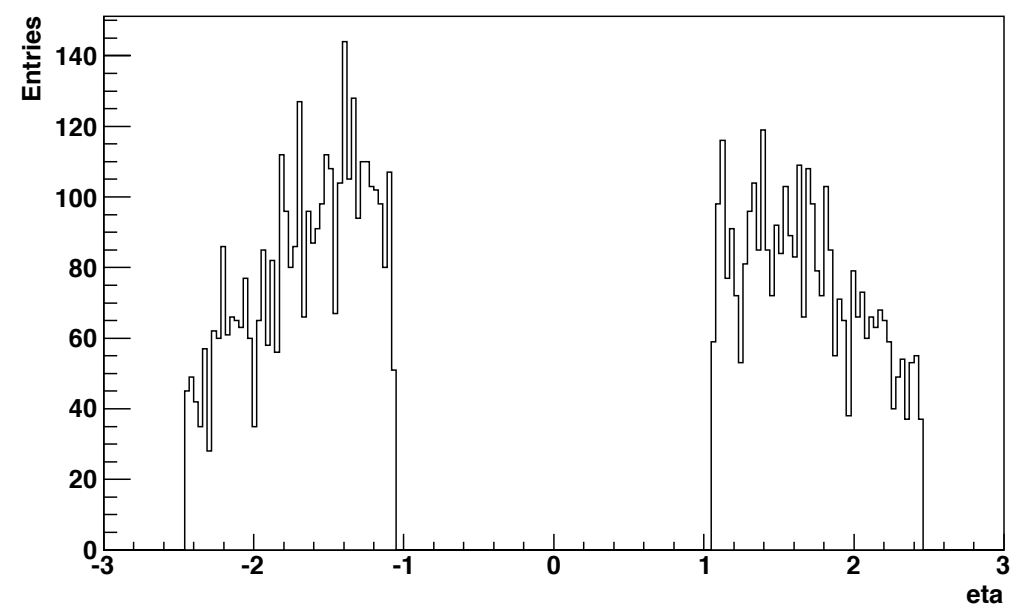


combined muonを伴ったMU20 ($p_T > 20$ GeV)

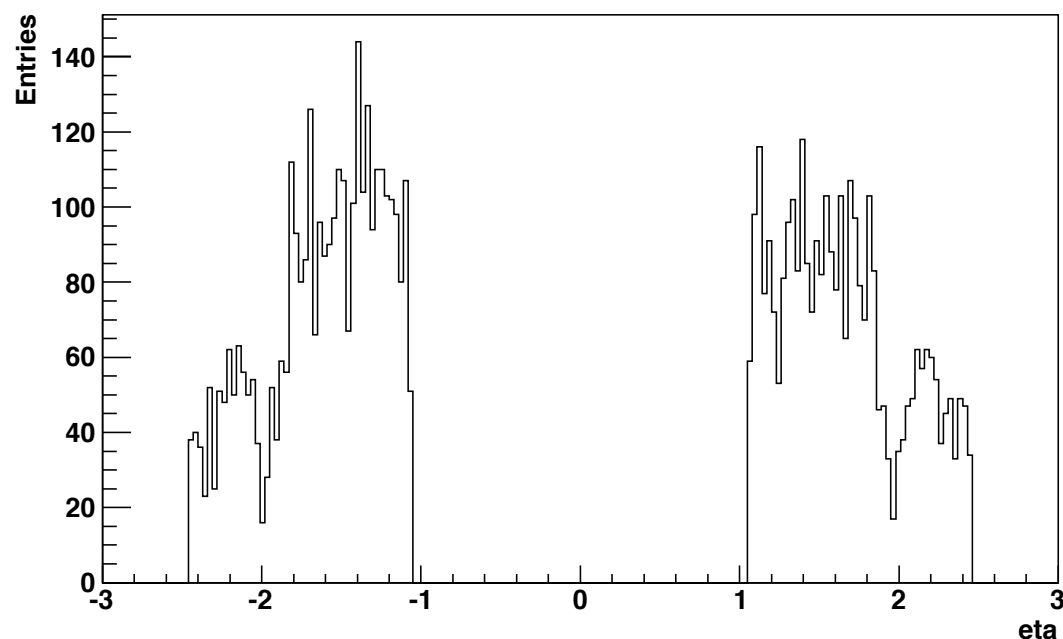
現在のL1_MU20 η 分布
histogram名 : Hpt_MU20



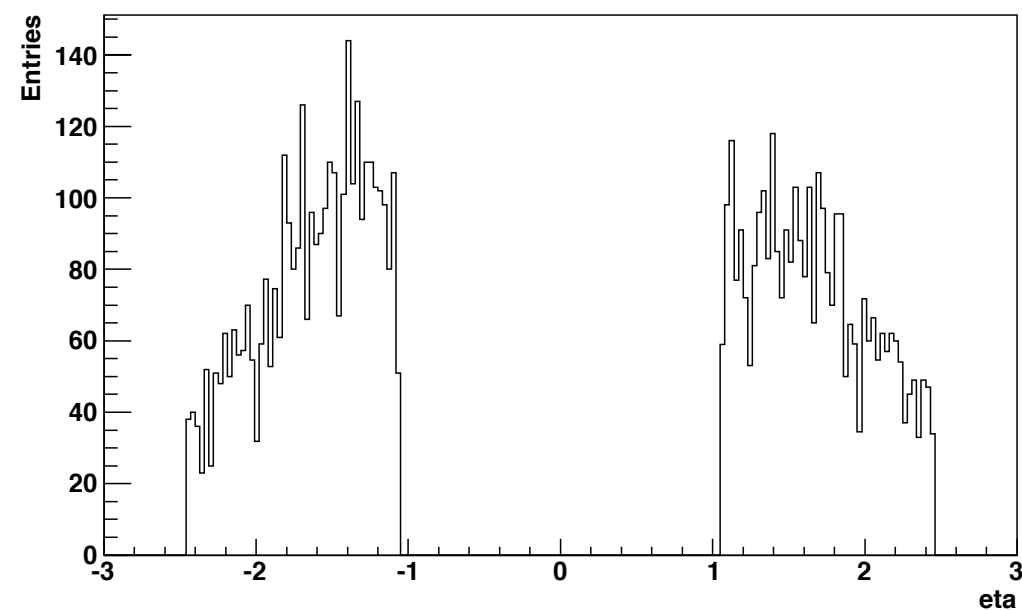
L1_MU20 η 分布 EI/FI cut後
histogram名 : Hpt{EIFI



L1_MU20 η 分布 EI/FI + NSW cut後
histogram名 : Hpt_NSW

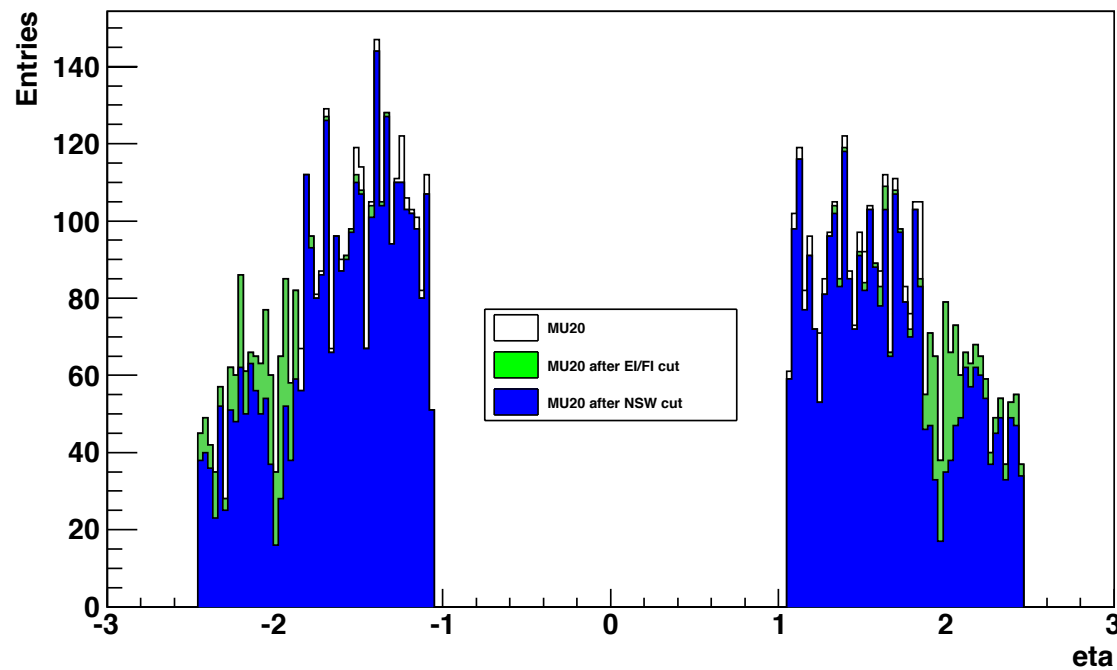


L1_MU20 η 分布 correction後
histogram名 : Hpt_Correction



combined muonを伴ったMU20 ($p_T > 20$ GeV)

Correctionなし



trigger数
MU20 : 7497

EI/FI cut
2 % 低下 ↓

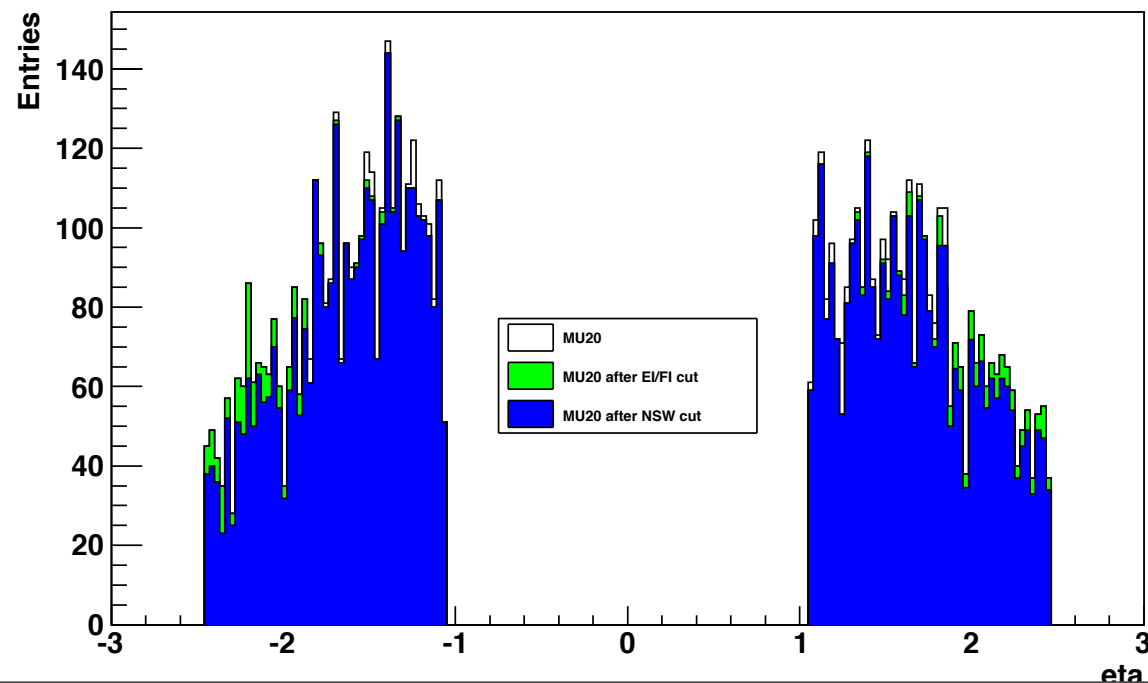
7335

NSW cut
8 % 低下 ↓

6735

11 % 低下

Correctionあり



trigger数
MU20 : 7497

EI/FI cut
2 % 低下 ↓

7335

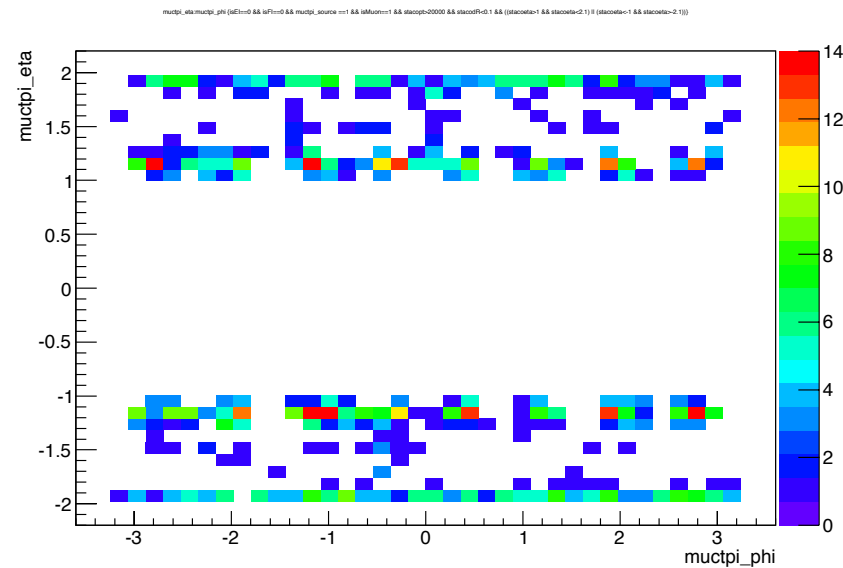
NSW cut
2 % 削減 ↓

7029

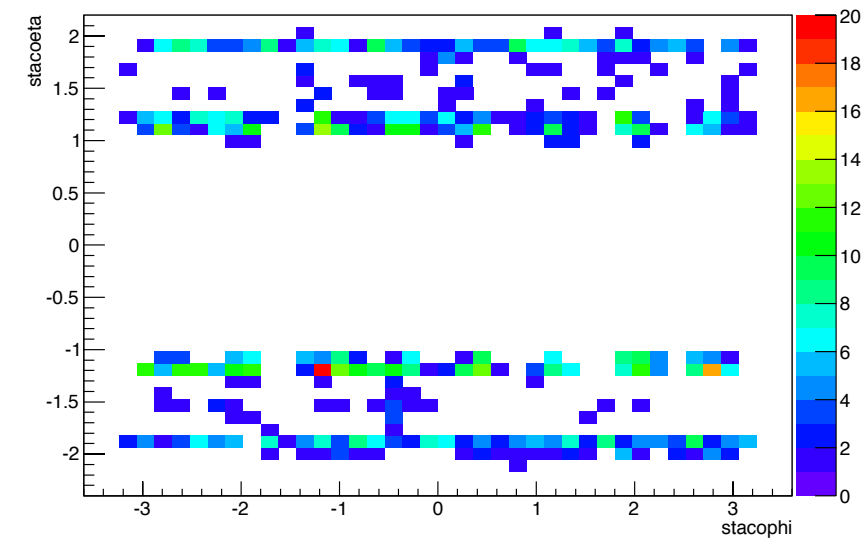
6 % 低下

inefficiency

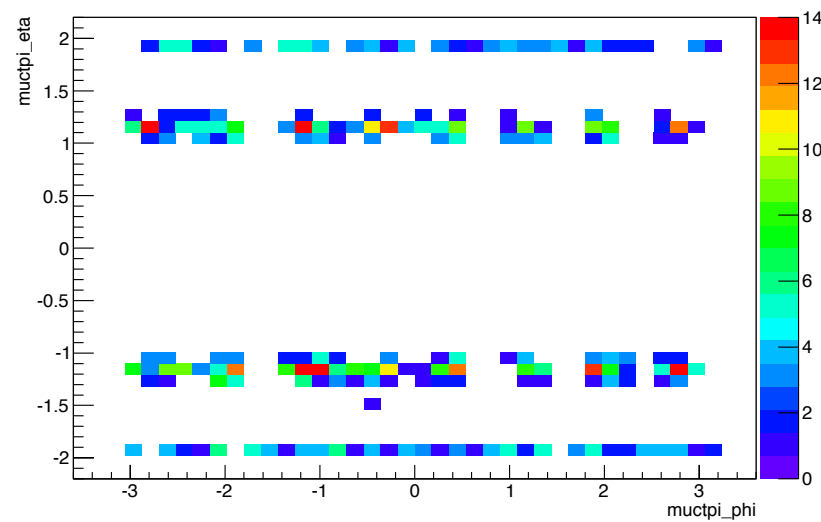
inefficiencyのRoI分布 (全TGC EndCap)



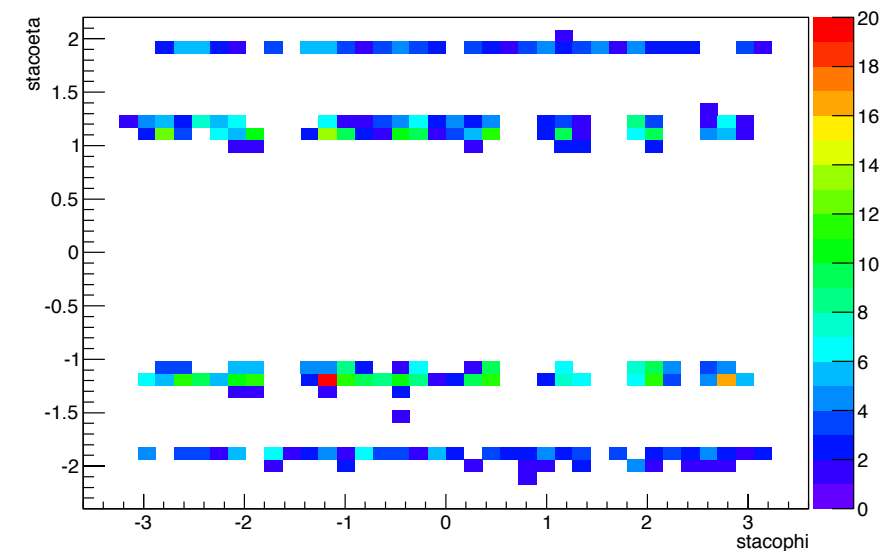
inefficiencyのstaco muon分布 (全TGC EndCap)



inefficiencyのRoI分布 (efficiency>0.8 のSSCのみ)



inefficiencyのstaco muon分布 (efficiency>0.8 のSSCのみ)



inefficiencyは $1 < |\eta| < 1.3$, $|\eta| = 2$ 付近に局在